

Top quark associated production ($t\bar{t}+W/Z/t\bar{t}/\gamma$) at CMS

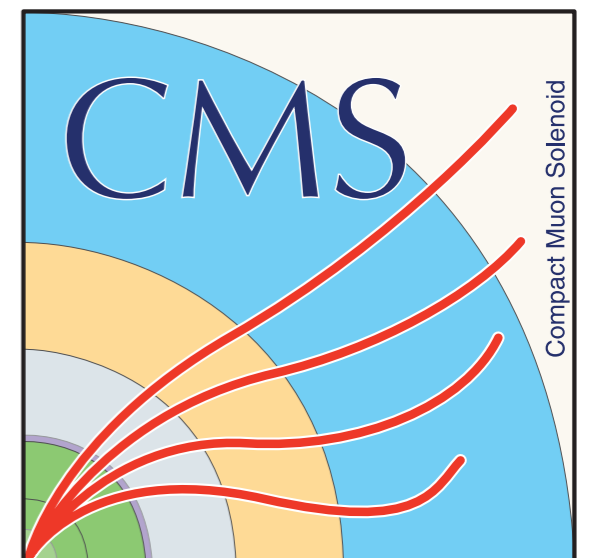
Danny Noonan for the CMS Collaboration
Florida Institute of Technology

TOP2018

*Bad Neuenahr, Germany
September 18, 2018*

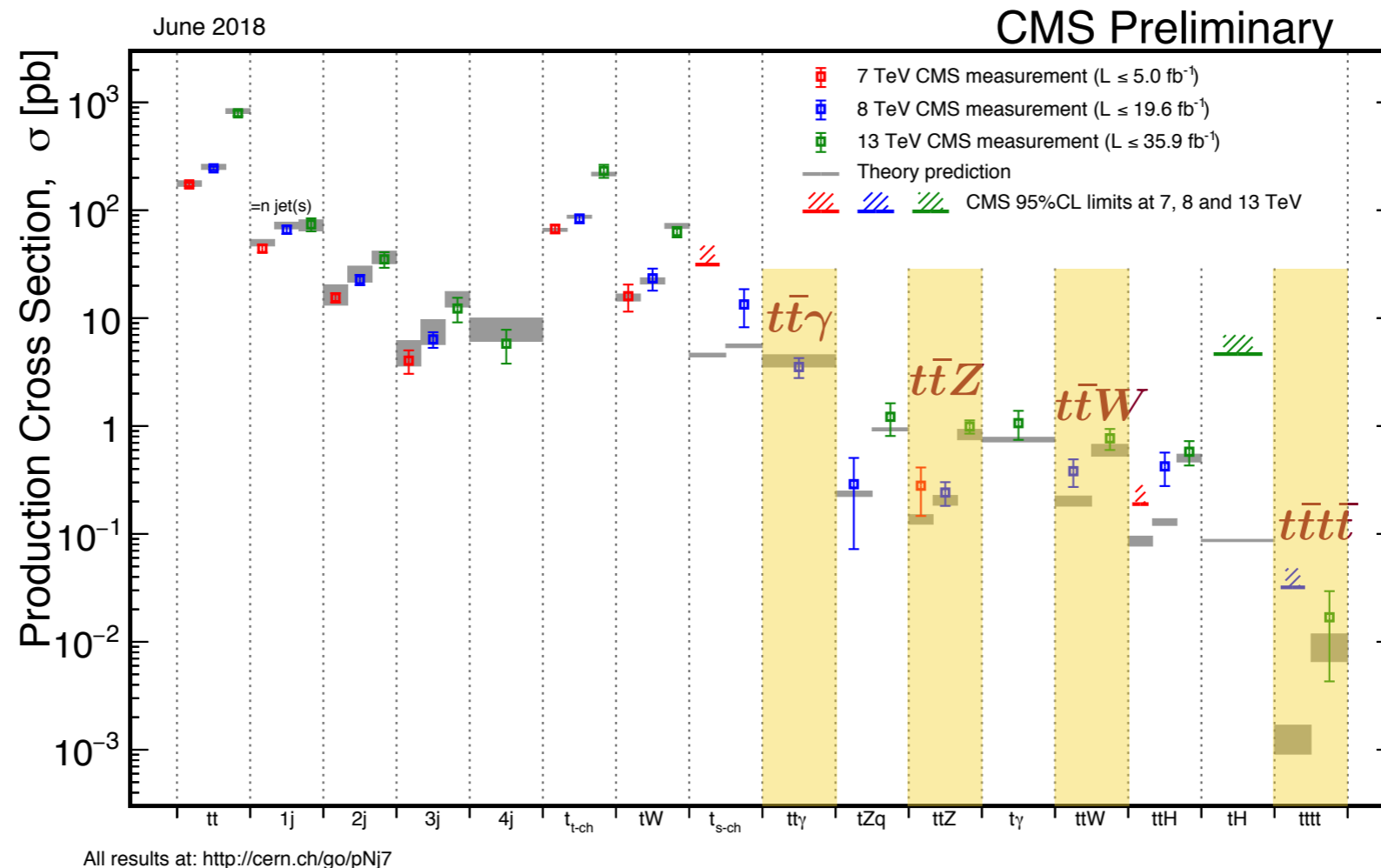


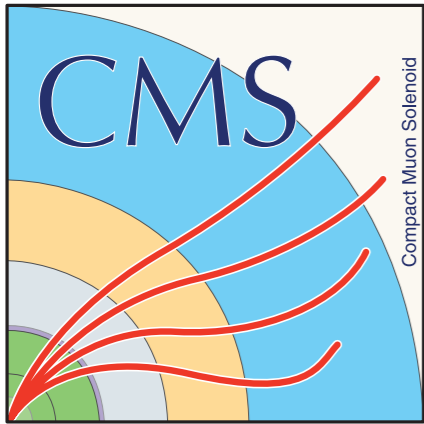
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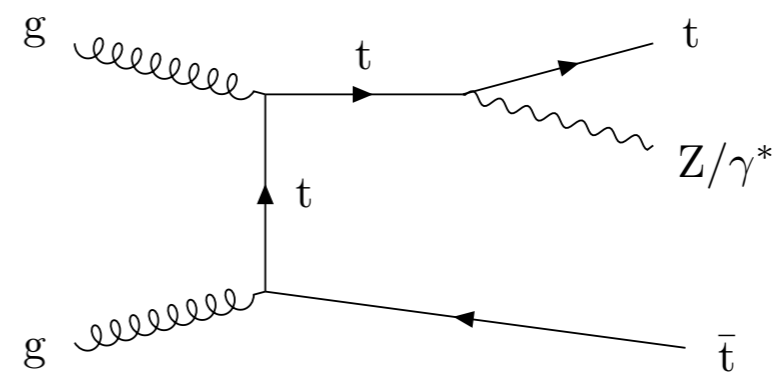
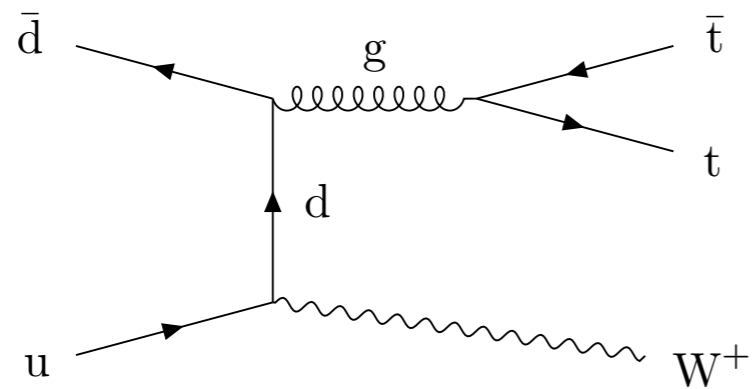
Associated Production

- Precision measurement of associated top quark pair production provides
 - Check the SM predictions in rare production channels
 - Direct test of top couplings
 - Window to new physics
 - Important background for BSM or rare SM searches



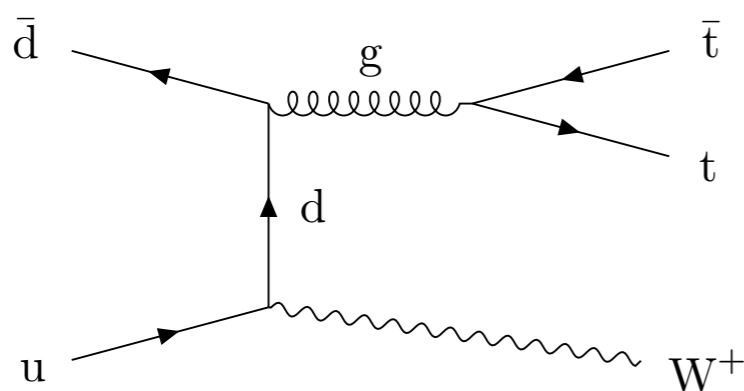


$t\bar{t}W$ & $t\bar{t}Z$



$t\bar{t}W$ & $t\bar{t}Z$

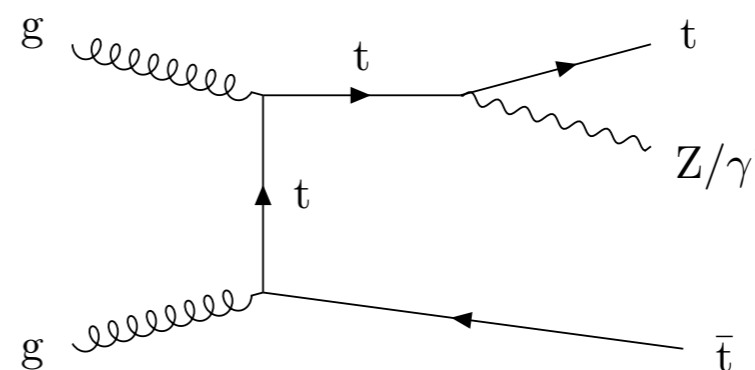
- Measurement of the $t\bar{t}W$ and $t\bar{t}Z$ production cross sections at 13 TeV
- Performed using 2016 dataset (35.9 fb⁻¹)



$t\bar{t}W$

$$\sigma_{\text{th.}}^{t\bar{t}W} = 0.61 \pm 0.08 \text{ pb}$$

- Measured in the same-sign (SS) dilepton final state

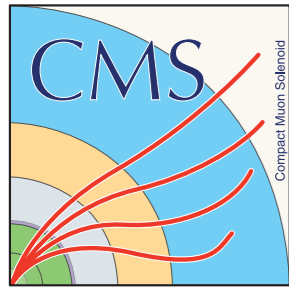


$t\bar{t}Z$

$$\sigma_{\text{th.}}^{t\bar{t}Z} = 0.84 \pm 0.10 \text{ pb}$$

- Measured in 3 & 4 lepton final states, containing opposite sign same flavor (OSSF) pair

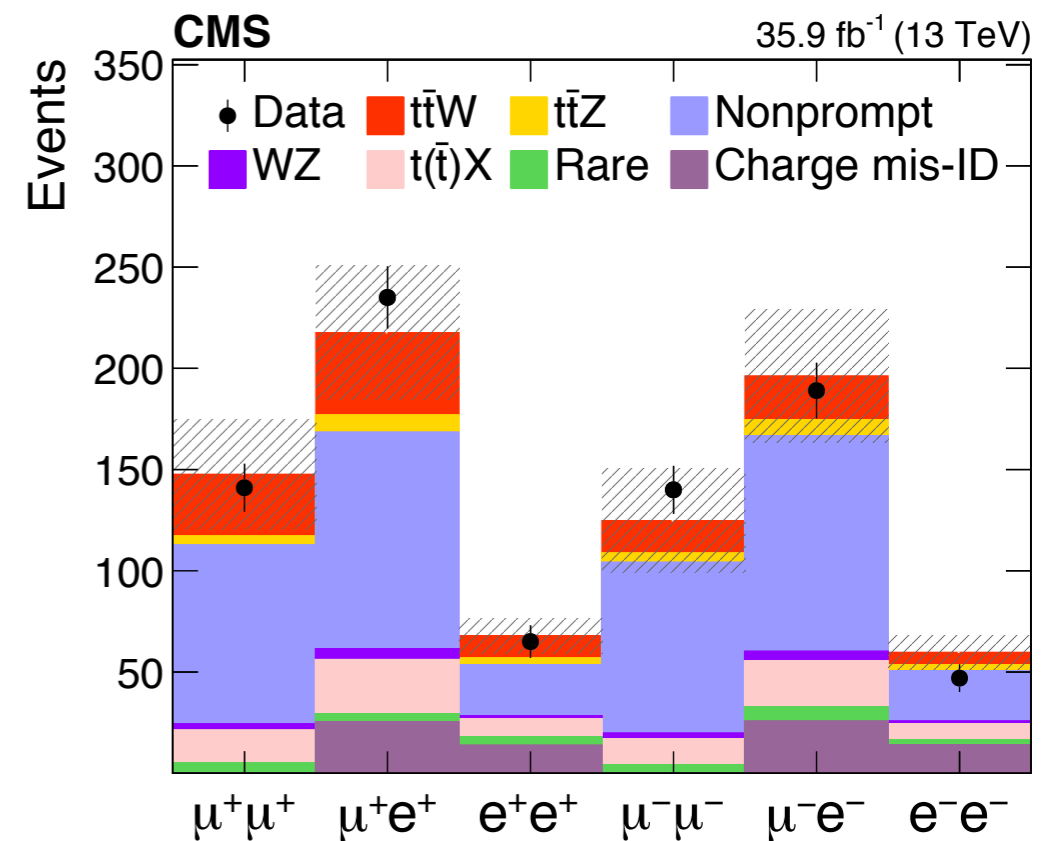
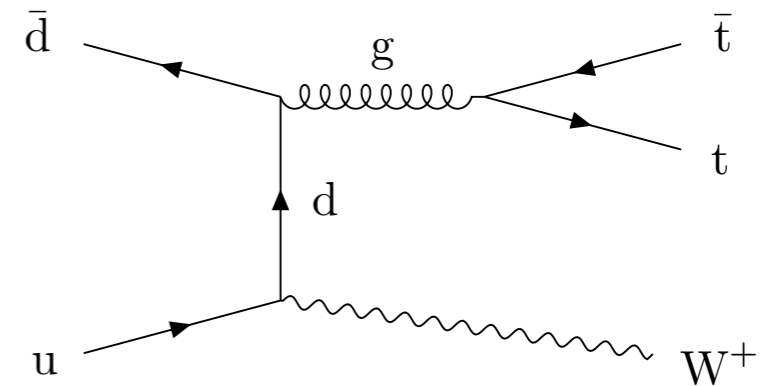
arXiv:1711.02547
JHEP 08 (2018) 011

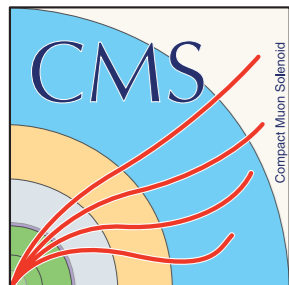


$t\bar{t}W$ Analysis



- Analysis selects same-sign dilepton events
 - Exactly 2 leptons (e or μ) with same sign
 - At least 2 jets and 1 b-tag
 - Reject events with $m_{\ell\ell} < 12$ GeV or dielectron events with $|m_{\ell\ell} - m_Z| < 15$ GeV
 - $p_T^{\text{miss}} > 30$ GeV
- Backgrounds:
 - Nonprompt leptons: estimated from loose selection sideband (tight-to-loose ratio)
 - Misidentified charge
 - $t(t)+X$ ($t\bar{t}H$, tZq , tWZ , tWq , ...)
 - Rare (WW , ZZ , $W\gamma$, $Z\gamma$, triboson)

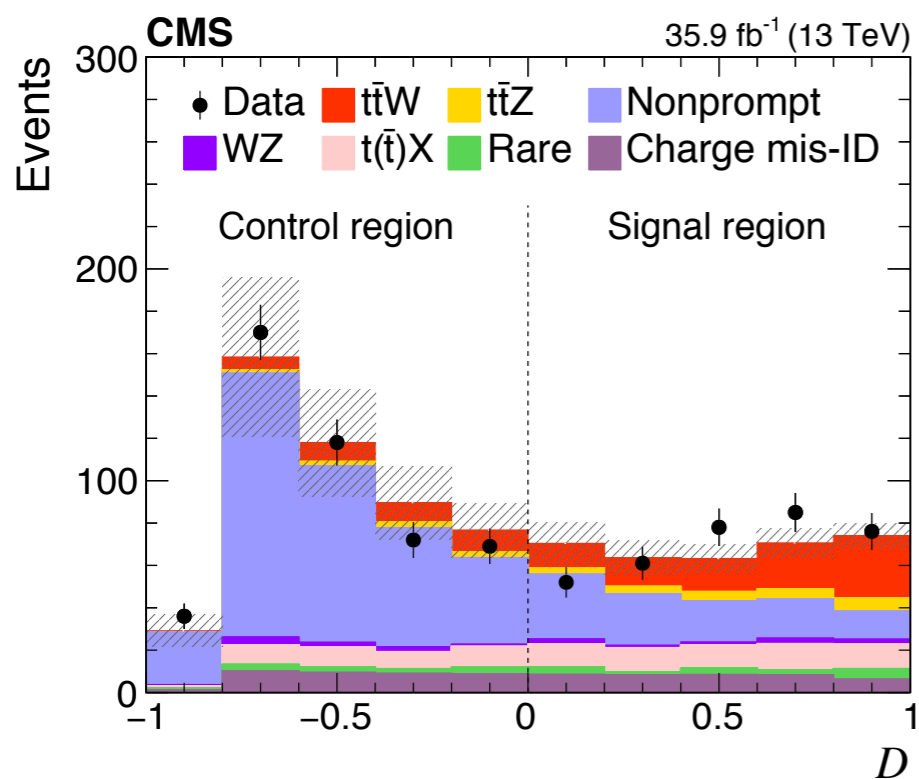




$t\bar{t}W$ Analysis

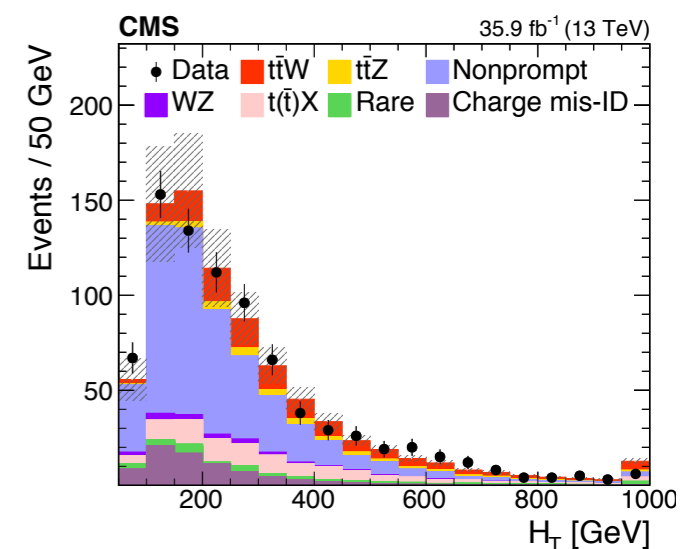
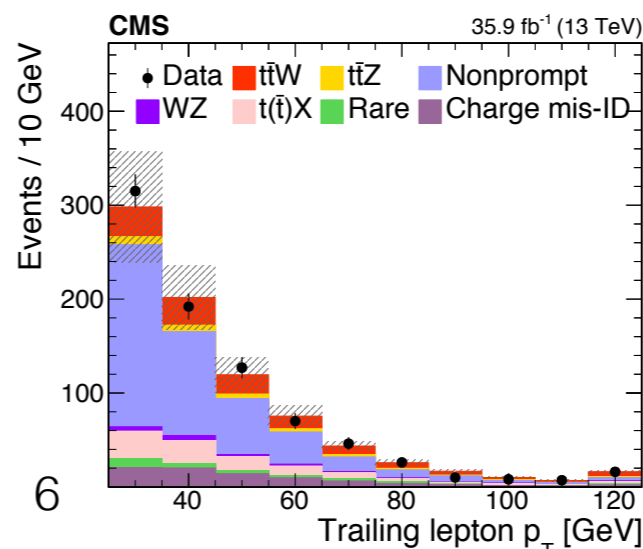
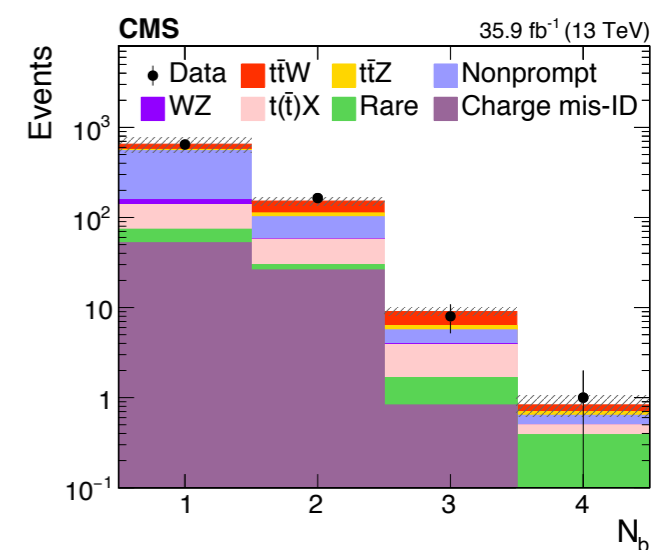
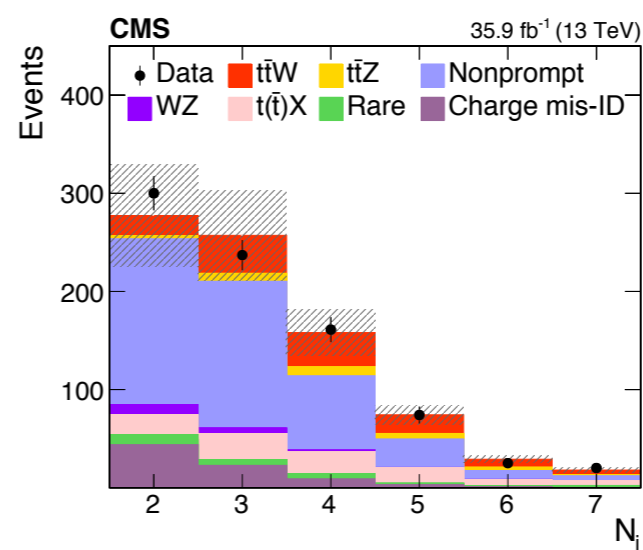


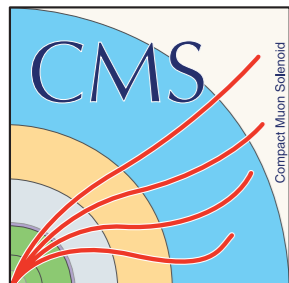
- Boosted Decision Tree classifier used to discriminate signal from non-prompt background
 - Using jet/b-jet multiplicities, and lepton/jet kinematics
- BDT discriminant (D) used to separate signal region ($D > 0$) and control region ($D < 0$)



BDT input variables

- N_j
- N_b
- p_T leading lepton
- p_T trailing lepton
- M_T leading lepton
- H_T : scalar sum of p_T of jets
- p_T^{miss}
- p_T leading and second leading jets
- ΔR between trailing lepton and nearest jet

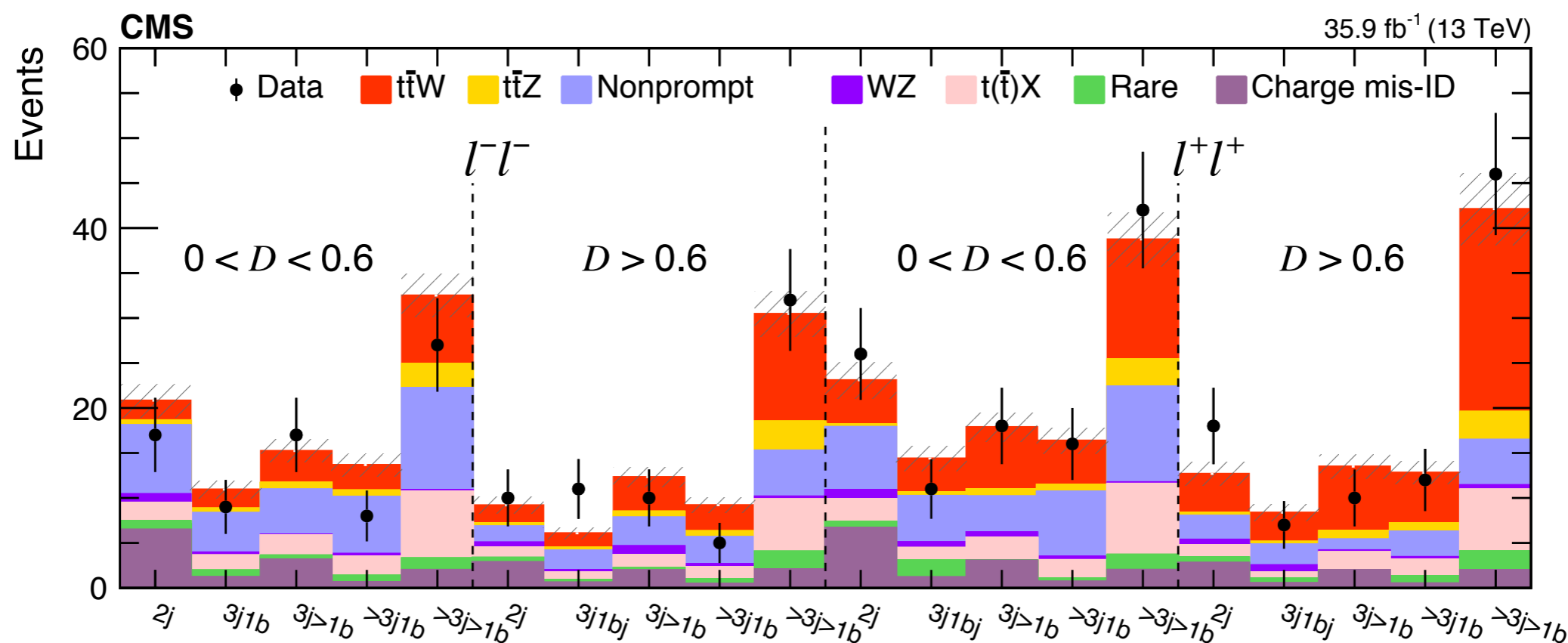
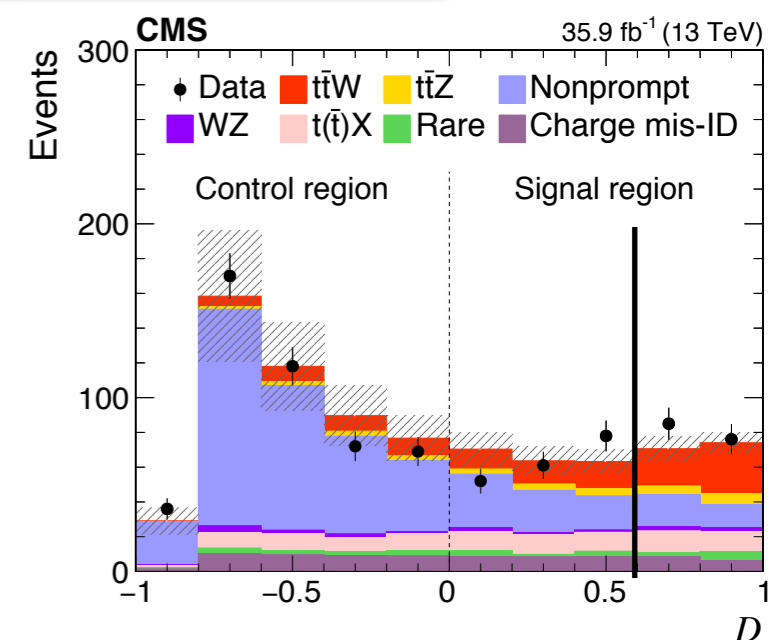


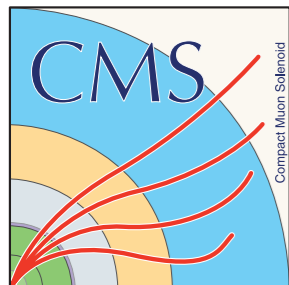


$t\bar{t}W$ Analysis Regions



- Signal region split up to define 20 exclusive signal regions
 - Split $\ell^+\ell^+$ from $\ell^-\ell^-$ to take advantage of difference between $t\bar{t}W^+$ and $t\bar{t}W^-$
 - Split in $0 < D < 0.6$ and $D > 0.6$
 - Define exclusive jet/b-jet multiplicity bins
 - $=2j, =3j=1b, =3j>1b, >3j=1b, >3j>1b$





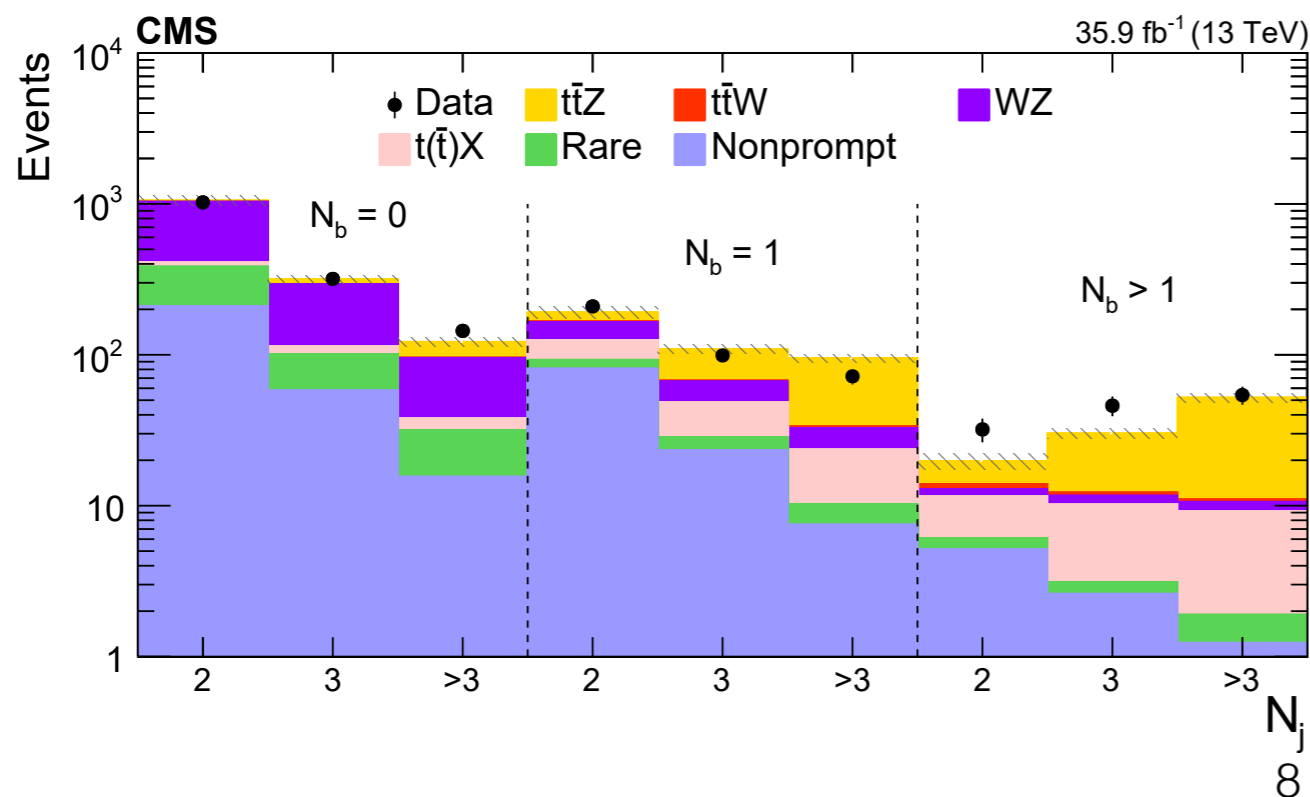
$t\bar{t}Z$ Analysis Regions



- Event selection for both three-lepton and four-lepton final states

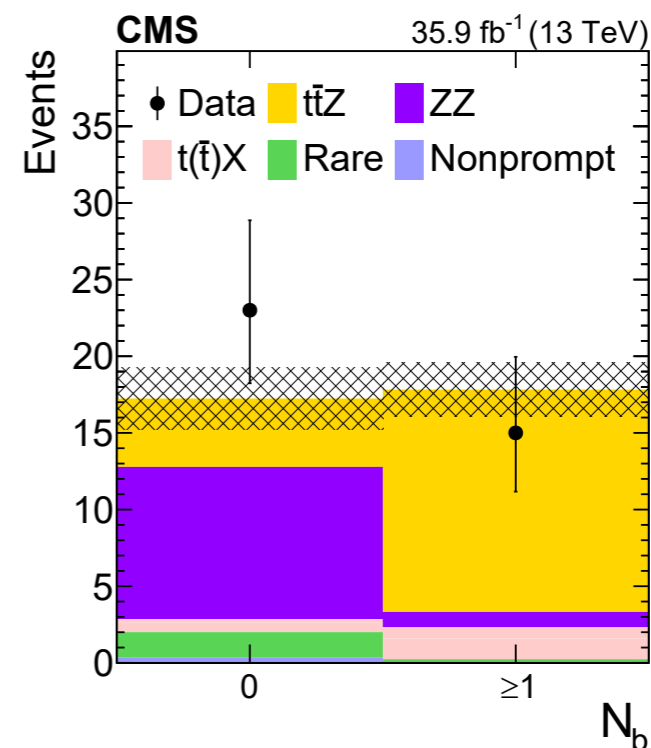
Three-leptons

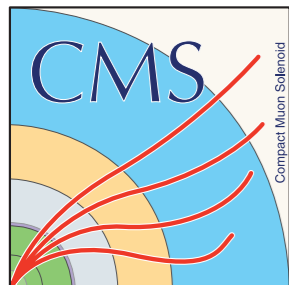
- Exactly three leptons ($\mu\mu\mu, \mu\mu e, \mu ee, eee$)
- One opposite sign/ same flavor (OSSF) pair with $|m_{\ell\ell} - m_Z| < 10$ GeV
- Form 9 exclusive bins
 - $N_j = 2, 3, >3$
 - $N_b = 0, 1, >1$



Four-leptons

- Exactly four leptons, 2 ℓ^+ , 2 ℓ^-
- One OSSF pair with $|m_{\ell\ell} - m_Z| < 20$ GeV
 - Veto $\mu\mu\mu\mu, \mu\mu ee, \text{ or } eeee$ events with second pair in mass peak
- Require ≥ 2 jets, split in 0b & $\geq 1b$





$t\bar{t}W$ & $t\bar{t}Z$ Results



- Likelihood function defined based on event yields in combination of same sign dilepton, 3-lepton, and 4-lepton categories.

- Fit to extract both the $t\bar{t}W$ and $t\bar{t}Z$ cross sections

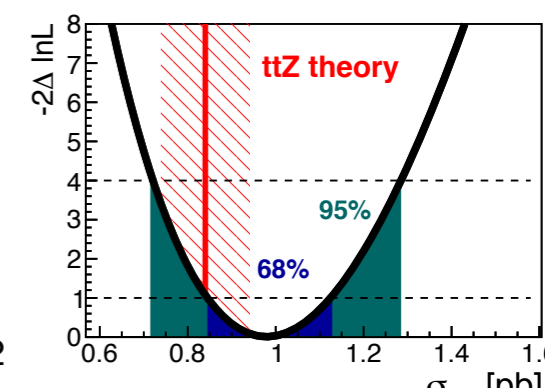
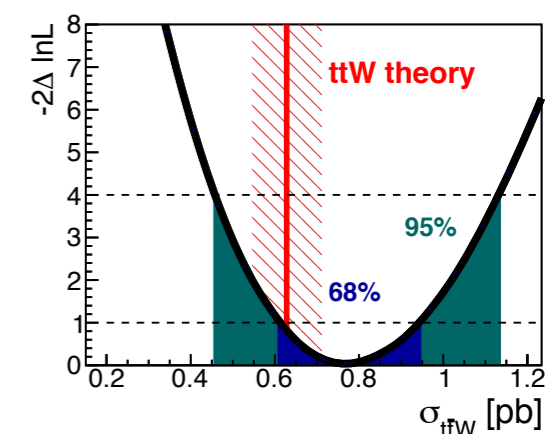
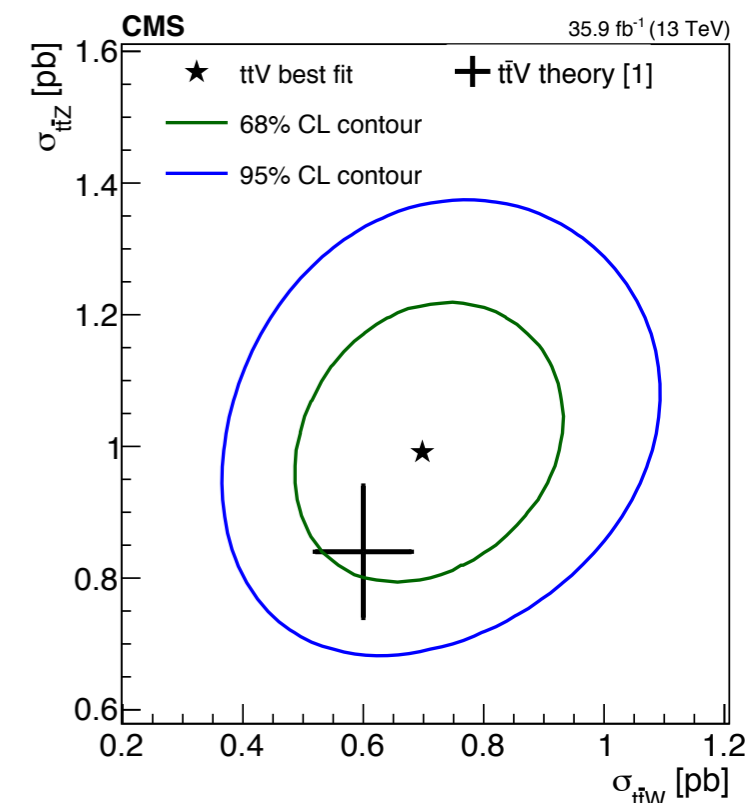
$$\sigma(pp \rightarrow t\bar{t}W) = 0.77^{+0.12}_{-0.11}(\text{stat})^{+0.13}_{-0.12}(\text{syst}) \text{ pb}$$

$$\sigma(pp \rightarrow t\bar{t}W^+) = 0.58 \pm 0.09(\text{stat})^{+0.09}_{-0.08}(\text{syst}) \text{ pb}$$

$$\sigma(pp \rightarrow t\bar{t}W^-) = 0.19 \pm 0.07(\text{stat}) \pm 0.06(\text{syst}) \text{ pb}$$

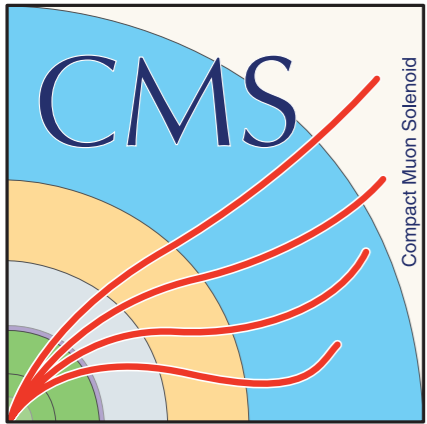
$$\sigma(pp \rightarrow t\bar{t}Z) = 0.99^{+0.09}_{-0.08}(\text{stat})^{+0.12}_{-0.10}(\text{syst}) \text{ pb}$$

- Systematics uncertainties from lepton identification, trigger efficiencies, non prompt background, b-tagging have largest effects on cross sections

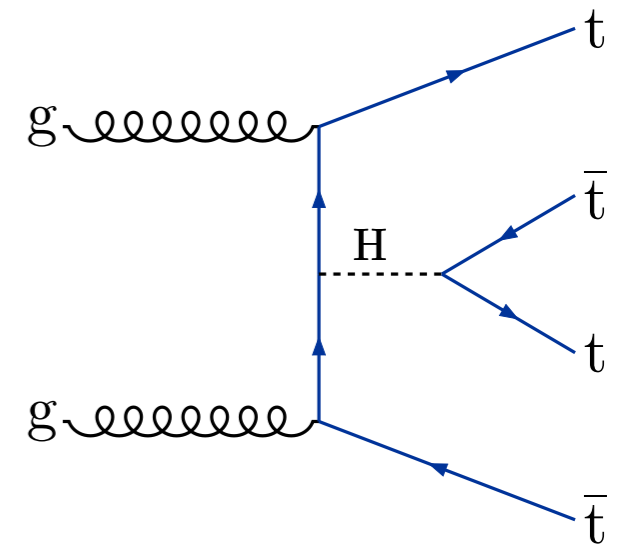
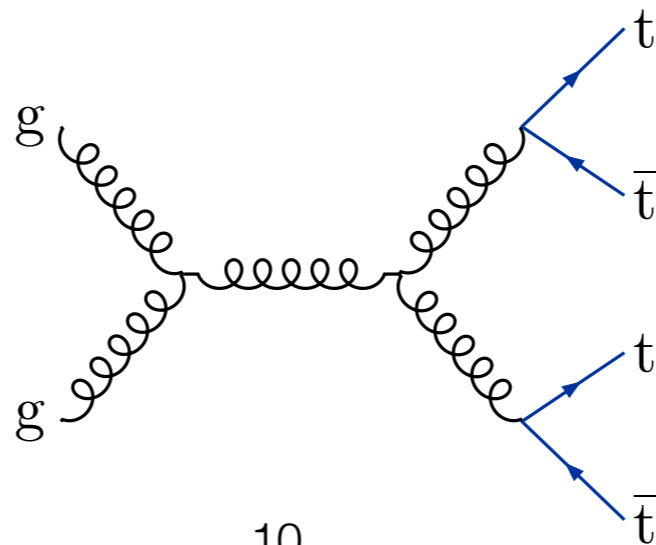
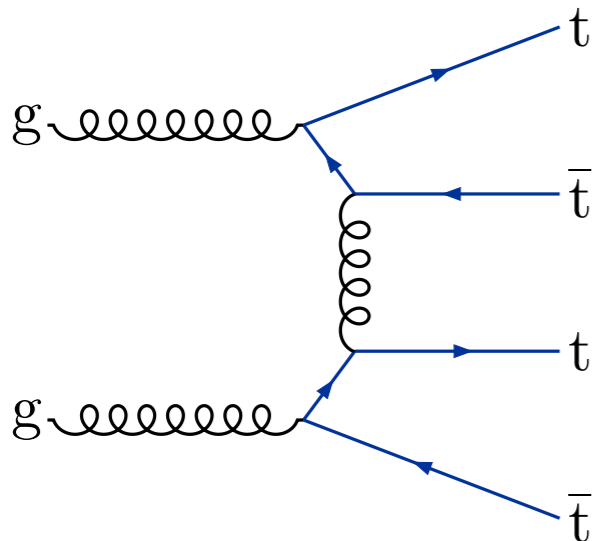


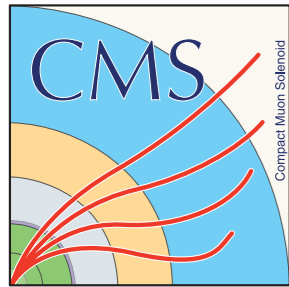
Channel	Expected significance	Observed significance
SS dilepton l^-l^- ($t\bar{t}W^-$)	2.4	2.3
SS dilepton l^+l^+ ($t\bar{t}W^+$)	4.2	5.5
SS dilepton $l^\pm l^\pm$ ($t\bar{t}W^\pm$)	4.5	5.3
Three-lepton ($t\bar{t}Z$)	>5.0	>5.0
Four-lepton ($t\bar{t}Z$)	4.7	4.5
Three- and four-lepton combined ($t\bar{t}Z$)	>5.0	>5.0

[arXiv:1711.02547](https://arxiv.org/abs/1711.02547)
[JHEP 08 \(2018\) 011](https://arxiv.org/abs/1711.02547)



$t\bar{t}t\bar{t}$





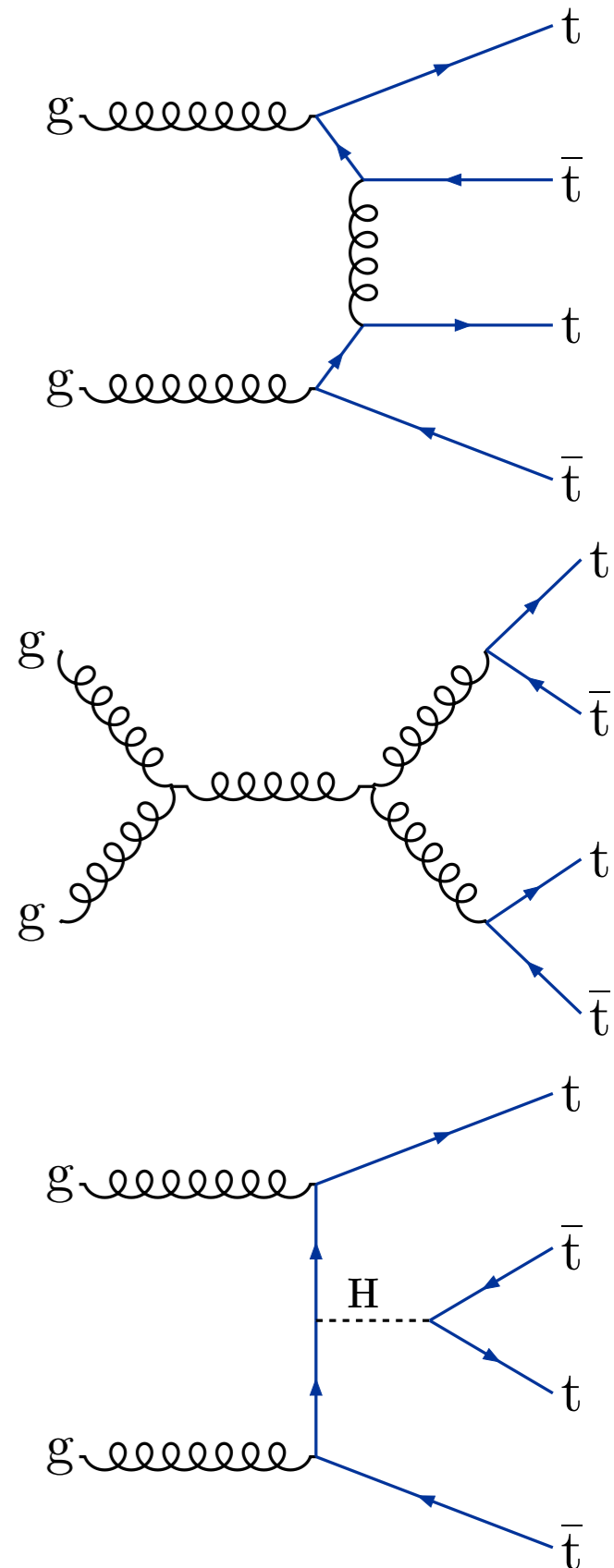
$t\bar{t}t\bar{t}$ Analysis

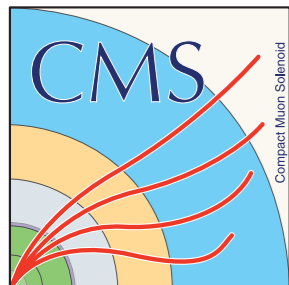


- Search for SM 4-top production
 - $\sigma(pp \rightarrow t\bar{t}t\bar{t}) = 9.2_{-2.4}^{+2.9}$ fb at NLO
 - Small in SM, but enhanced in many BSM theories
- Measured in same-sign dilepton and 3+ lepton final states
- Selection requires ≥ 2 jets, ≥ 2 b-jets, $H_T > 300$ GeV, and $p_T^{\text{miss}} > 50$ GeV
- Define signal regions based on lepton, jet, and b-jet multiplicities

arXiv:1710.10614
Eur. Phys. J. C 78
(2018) 140

N_ℓ	N_b	N_{jets}	Region	
2	2	≤ 5	CRW	
		6	SR1	
		7	SR2	
	≥ 8	SR3		
	3	5, 6	≥ 7	SR4
			≥ 7	SR5
≥ 4		≥ 5	SR6	
≥ 3	2	≥ 5	SR7	
	≥ 3	≥ 4	SR8	
Inverted Z veto			CRZ	

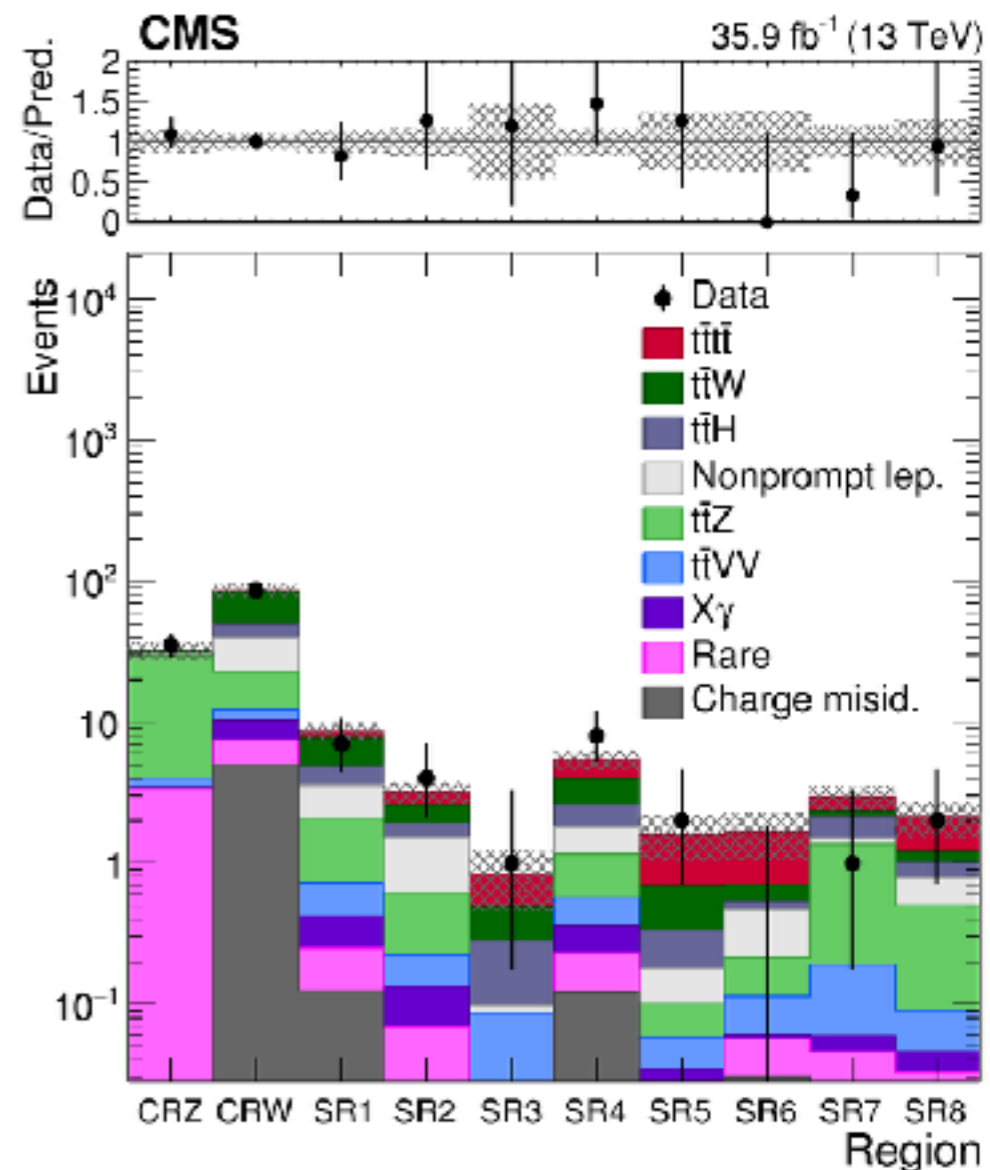
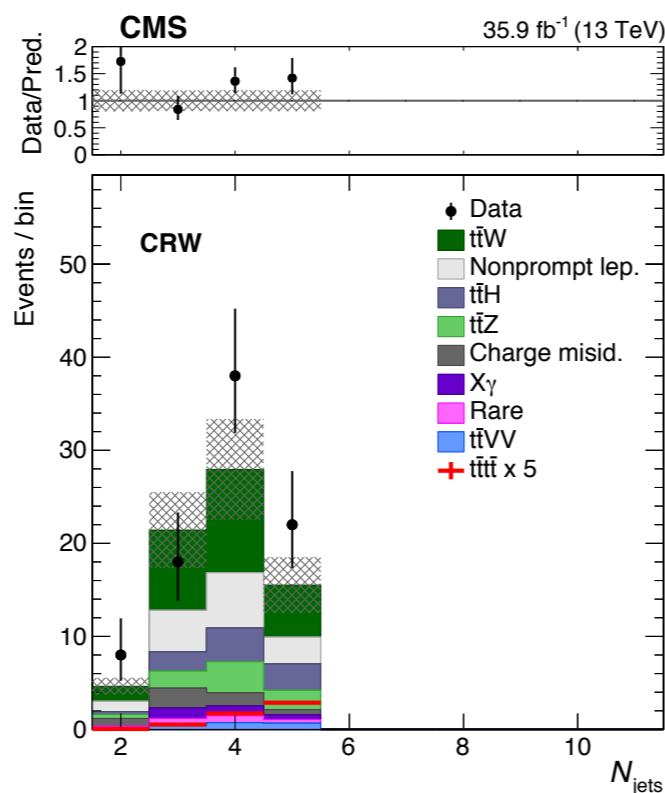
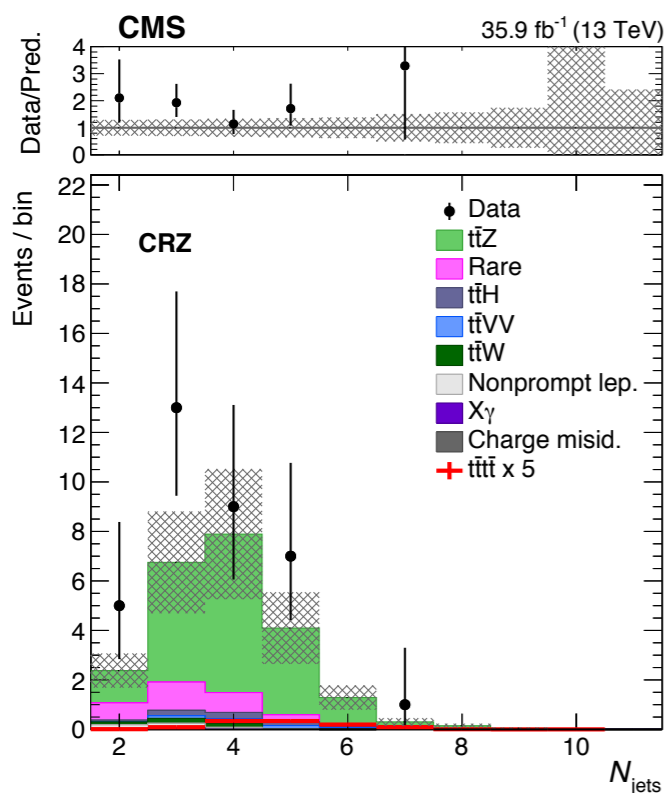




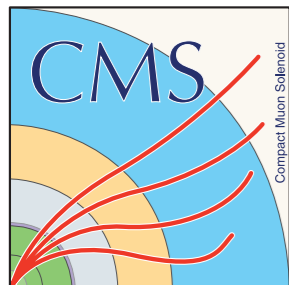
$t\bar{t}t\bar{t}$ Analysis



- Backgrounds come from two main categories
- Rare top multilepton processes ($t\bar{t}W$, $t\bar{t}Z$, $t\bar{t}H$, ...):
 - Estimated with simulation, and verified in control regions (CRW, CRZ)
- Non prompt leptons events:
 - Estimated in each region with “tight-to-loose” method



N_ℓ	N_b	N_{jets}	Region
2	2	≤ 5	CRW
		6	SR1
		7	SR2
	≥ 3	≥ 8	SR3
		5, 6	SR4
		≥ 7	SR5
≥ 3	≥ 4	≥ 5	SR6
	2	≥ 5	SR7
	≥ 3	≥ 4	SR8
Inverted Z veto			CRZ



$t\bar{t}t\bar{t}$ Analysis



- Likelihood function defined for event yields in 2 CR's and 8 SR's, fit to extract $t\bar{t}t\bar{t}$ signal yield

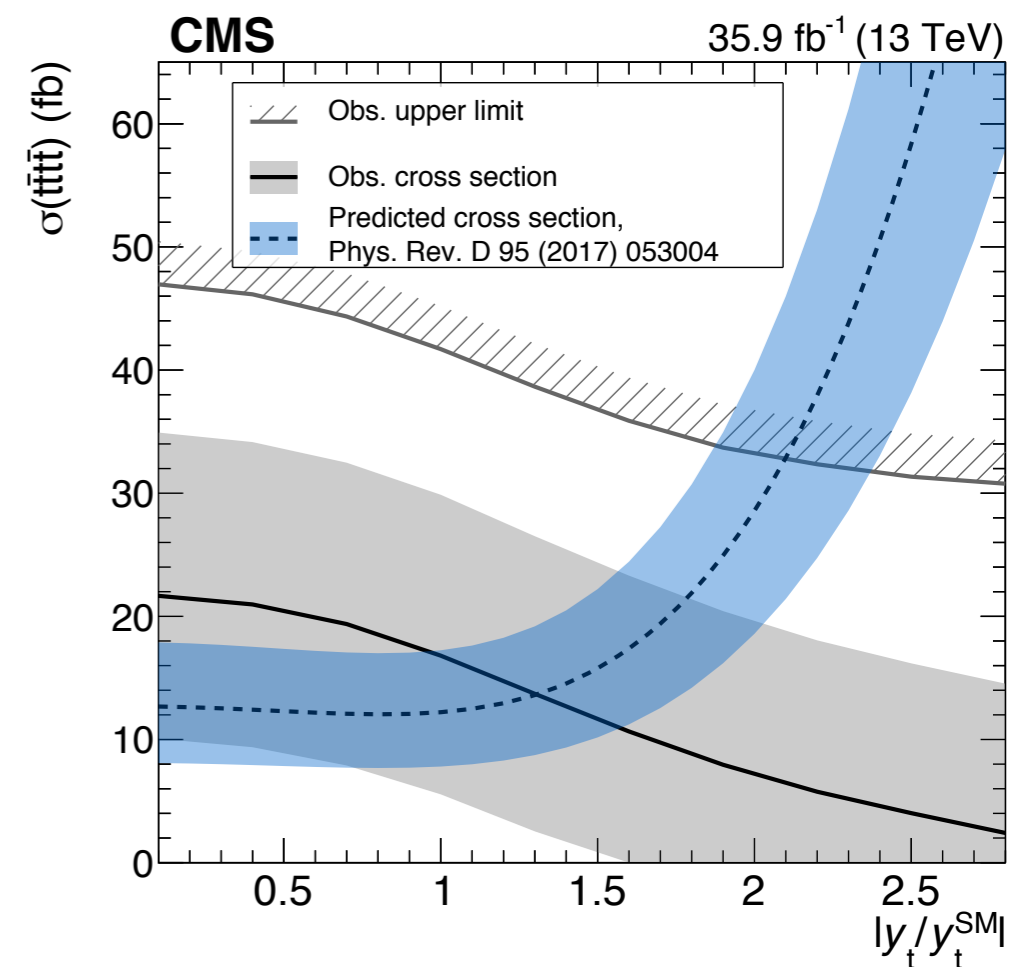
$$\sigma^{\text{meas.}}(pp \rightarrow t\bar{t}t\bar{t}) = 16.9^{+13.8}_{-11.4} \text{ fb}$$

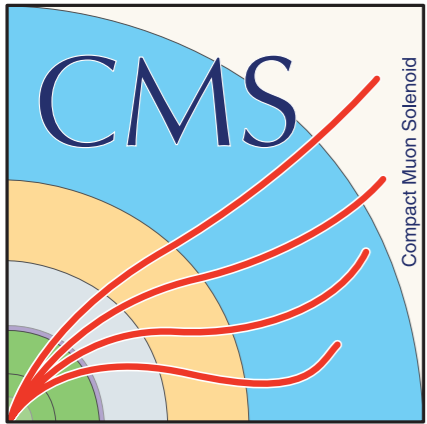
$$\sigma^{\text{th.}}(pp \rightarrow t\bar{t}t\bar{t}) = 9.2^{+2.9}_{-2.4} \text{ fb}$$

- 95% CL upper limit of 41.7 fb
- Observed significance of 1.6σ (expected 1.0σ)
- Yukawa coupling limit at 95% of $|y_t/y_t^{\text{SM}}| < 2.1$

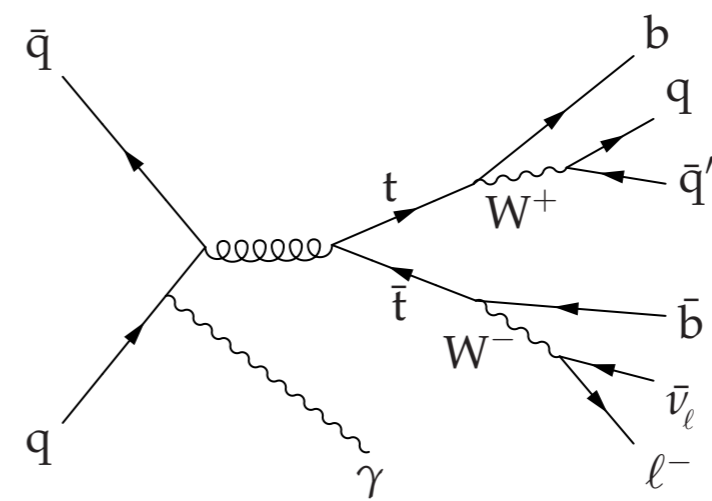
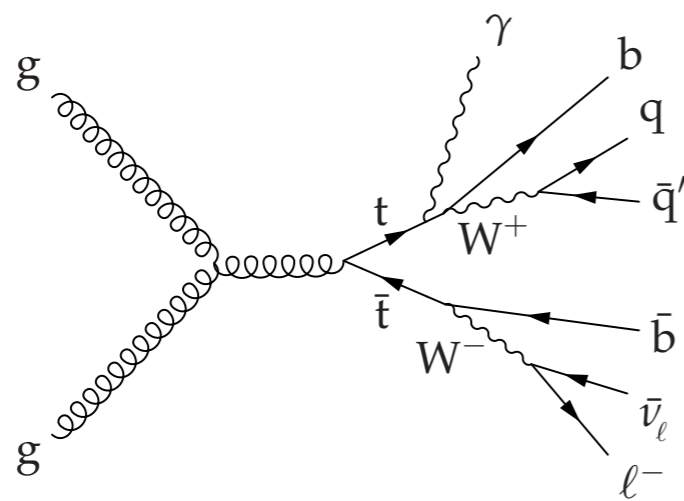
	SM background	$t\bar{t}t\bar{t}$	Total	Observed
CRZ	31.7 ± 4.6	0.4 ± 0.3	32.1 ± 4.6	35
CRW	83.7 ± 8.8	1.9 ± 1.2	85.6 ± 8.6	86
SR1	7.7 ± 1.2	0.9 ± 0.6	8.6 ± 1.2	7
SR2	2.6 ± 0.5	0.6 ± 0.4	3.2 ± 0.6	4
SR3	0.5 ± 0.3	0.4 ± 0.2	0.8 ± 0.4	1
SR4	4.0 ± 0.7	1.4 ± 0.9	5.4 ± 0.9	8
SR5	0.7 ± 0.2	0.9 ± 0.6	1.6 ± 0.6	2
SR6	0.7 ± 0.2	1.0 ± 0.6	1.7 ± 0.6	0
SR7	2.3 ± 0.5	0.6 ± 0.4	2.9 ± 0.6	1
SR8	1.2 ± 0.3	0.9 ± 0.6	2.1 ± 0.6	2

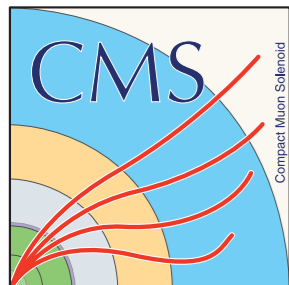
arXiv:1710.10614
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$t\bar{t}\gamma$

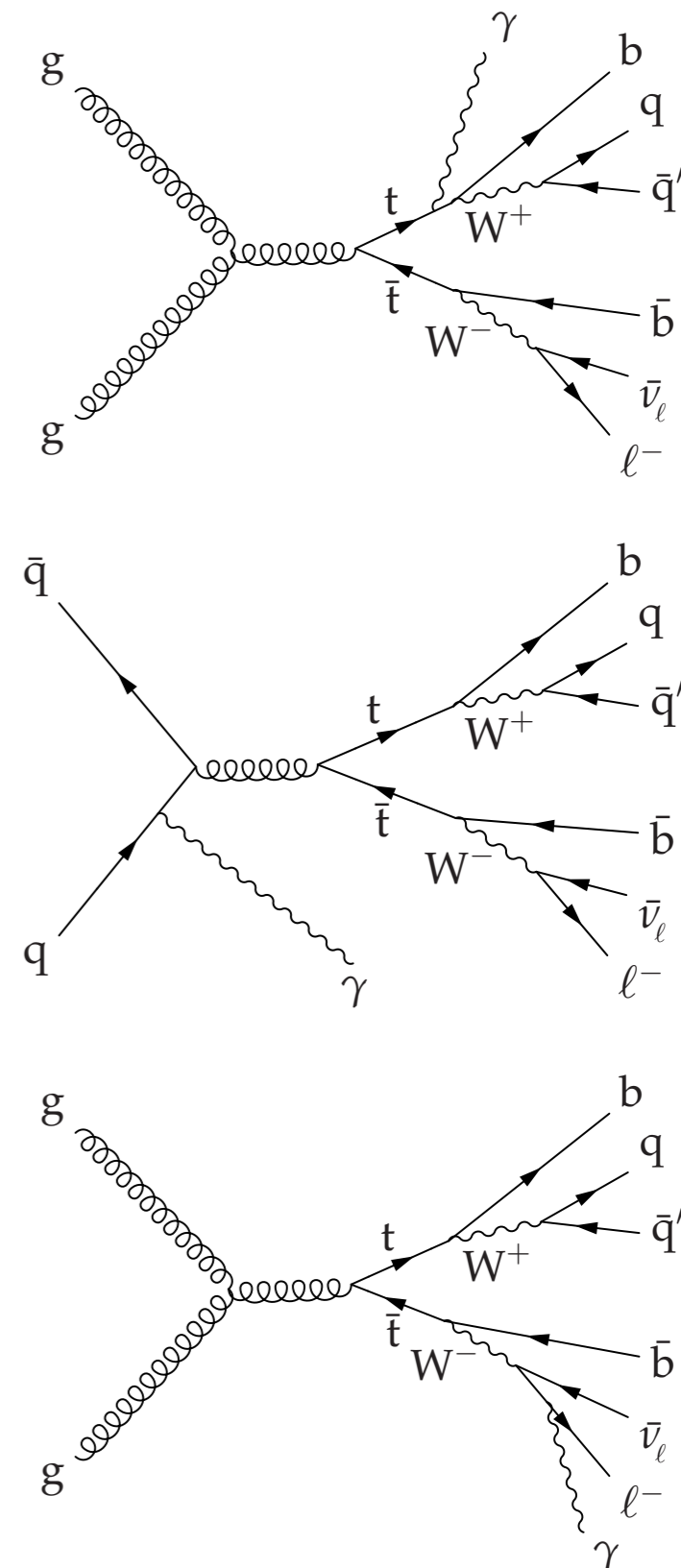




$t\bar{t}\gamma$ Analysis

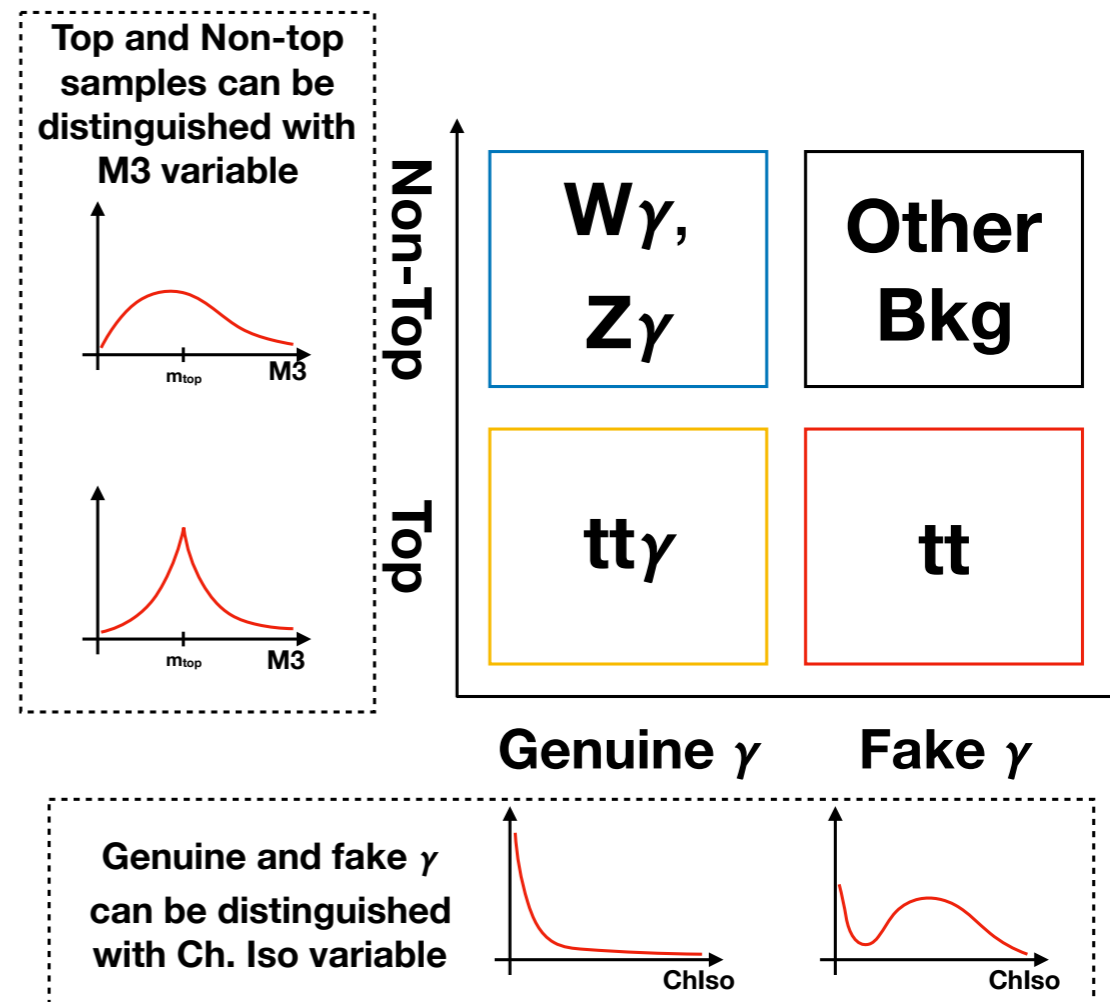
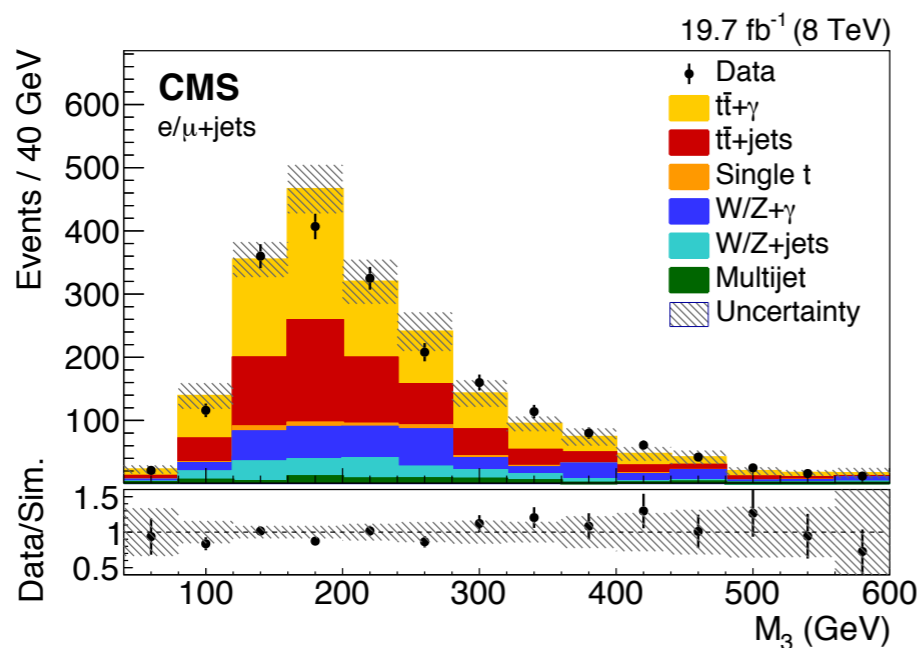


- Analysis with 8 TeV data collected in 2012
- Measured in the lepton+jets (e or μ) final state
- Select events with leptons+jets signature with reconstructed photon
 - Exactly one isolated lepton, ≥ 3 jets, ≥ 1 b-tag, $p_T^{\text{miss}} > 25$ GeV
 - At least one isolated photon, $p_T > 25$ GeV
- Backgrounds come mainly from two categories:
 - Top pair events with a fake photon
 - Non-top events ($W/Z+\gamma$) with a real photon

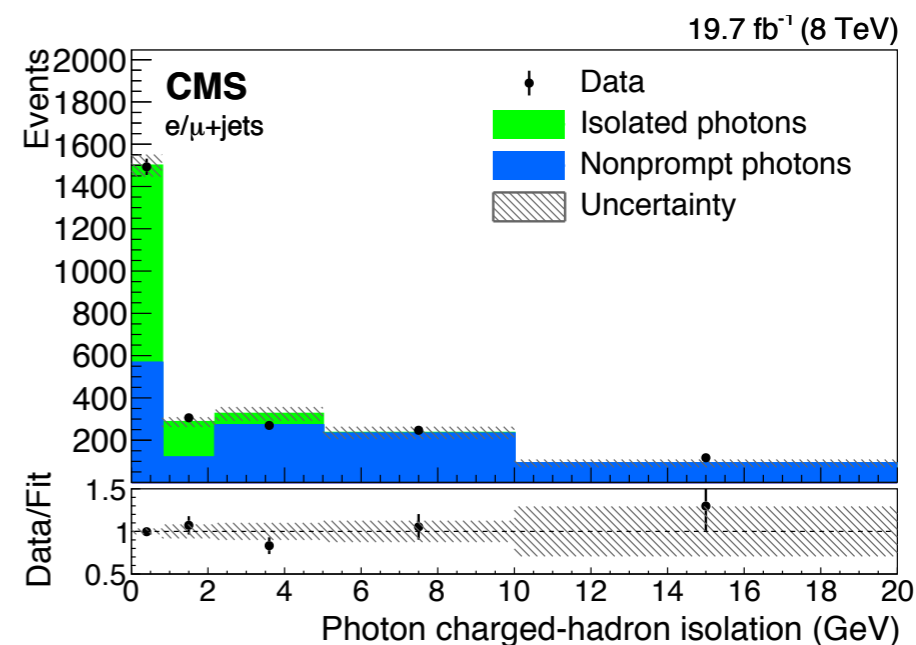


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arXiv:1706.08128

$t\bar{t}\gamma$ Analysis



- Strategy used is to:
 - Fit M_3 distribution to distinguish top from non-top events (measuring top purity)
 - Fit photon isolation to distinguish genuine and fake photons (measuring photon purity)



$t\bar{t}\gamma$ Results

- Combine measurements of photon purity, top quark purity, and total event yield in likelihood to extract number of $t\bar{t}\gamma$ events

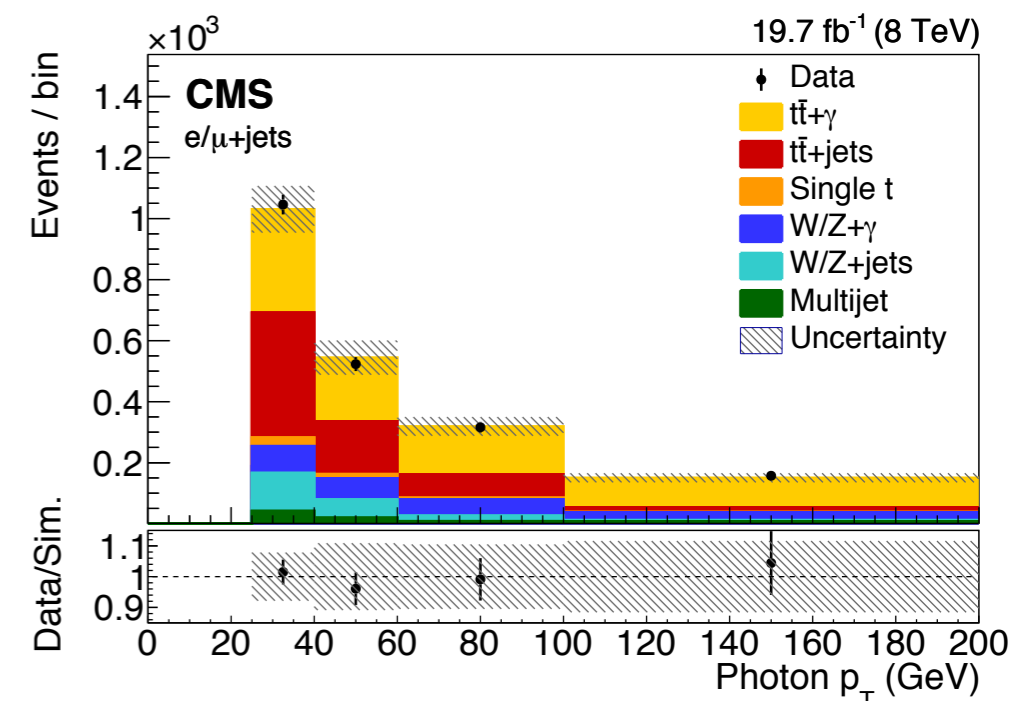
$$\chi^2 = \frac{(\pi_\gamma^{\text{data}} - \pi_\gamma^{\text{MC}})^2}{\sigma_{\pi_\gamma}^2} + \frac{(\pi_{t\bar{t}}^{\text{data}} - \pi_{t\bar{t}}^{\text{MC}})^2}{\sigma_{\pi_{t\bar{t}}}^2} + \frac{(N^{\text{data}} - N^{\text{MC}})^2}{\sigma_N^2}$$

$$N_{t\bar{t}\gamma} = 338 \pm 53 \text{ (stat) in } e + \text{jets}$$

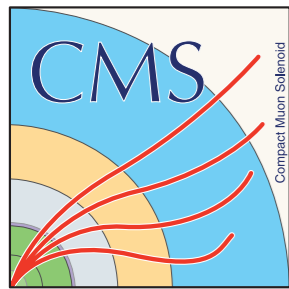
$$N_{t\bar{t}\gamma} = 442 \pm 69 \text{ (stat) in } \mu + \text{jets}$$

- Measure ratio to $t\bar{t}$ (R), extract cross section by multiplying ratio by measured top pair cross section
- Largest uncertainty is statistical (associated with fit method and emphasis on data-driven estimates), followed by uncertainties on top mass and jet energy scale

Category	R	$\sigma_{t\bar{t}+\gamma}^{\text{fid}}$ (fb)	$\sigma_{t\bar{t}+\gamma} \mathcal{B}$ (fb)
e+jets	$(5.7 \pm 1.8) \times 10^{-4}$	138 ± 45	582 ± 187
μ +jets	$(4.7 \pm 1.3) \times 10^{-4}$	115 ± 32	453 ± 124
Combination	$(5.2 \pm 1.1) \times 10^{-4}$	127 ± 27	515 ± 108
Theory	—	—	$592 \pm 71 \text{ (scales)} \pm 30 \text{ (PDFs)}$



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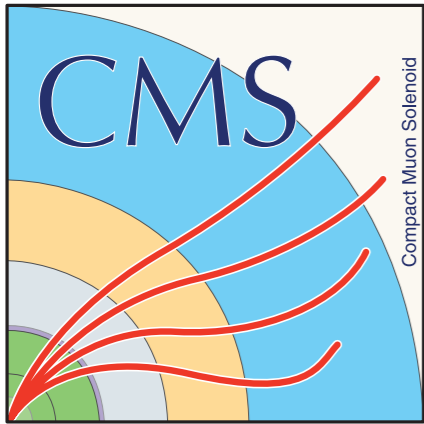


Summary & Outlook

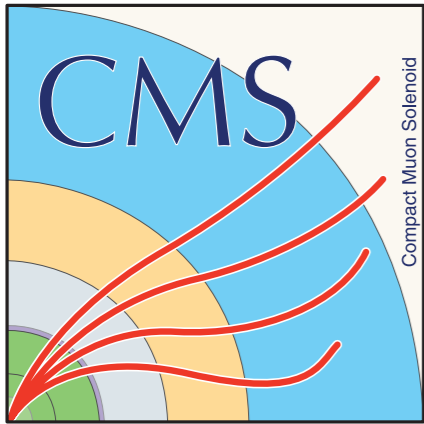


- Results of many CMS measurements of top quark associated production presented
- Measurements agree with theory predictions
- Further improvements to measurements in the pipeline:
 - $t\bar{t}+W$ & $t\bar{t}+Z$: improvements to the lepton identification reduce nonprompt backgrounds and systematics
 - $t\bar{t}t\bar{t}$: Larger datasets to improve statistical uncertainty
 - $t\bar{t}+\gamma$: More data (13 TeV measurement) and improvements to analysis technique to push down statistical and systematic uncertainties

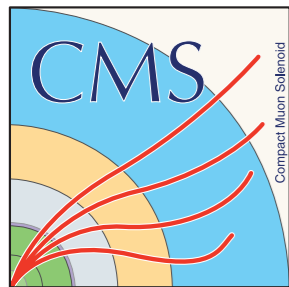
Process	σ	(stat)	(syst)
$t\bar{t}W$	0.77 pb	15%	17%
$t\bar{t}Z$	0.99 pb	9%	12%
$t\bar{t}t\bar{t}$	16.9 fb		81%
$t\bar{t}\gamma \times BR$	515 fb		23%



Backup Slides



ttW/ttZ Supporting Material



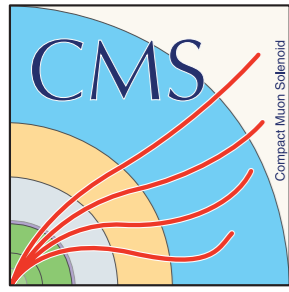
$t\bar{t}W$ Selection



- SS dilepton, $p_T > 25$ GeV
- ≥ 2 jets, ≥ 1 b-tag
- $p_T > 30$ GeV

BDT Variables

- N_j
- N_b
- H_T : scalar sum of p_T of jets
- p_T^{miss}
- p_T leading lepton
- p_T trailing lepton
- M_T leading lepton
- p_T leading and second leading jets
- ΔR between trailing lepton and nearest jet



$t\bar{t}W$ Event Yields

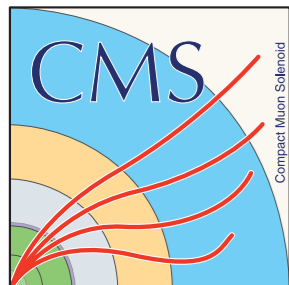


SS Dilepton
 $D > 0$

		N_j	N_b	Background	$t\bar{t}W$	$t\bar{t}Z$	Total	Observed
l^-l^-	$0 < D < 0.6$	2	>0	18.1 ± 1.8	2.2 ± 0.4	0.5 ± 0.1	20.8 ± 1.9	17
		3	1	8.3 ± 0.9	2.1 ± 0.4	0.5 ± 0.1	10.9 ± 0.9	9
			>1	10.9 ± 1.1	3.5 ± 0.6	0.8 ± 0.1	15.2 ± 1.3	17
		>3	1	10.1 ± 1.1	2.8 ± 0.5	0.7 ± 0.2	13.7 ± 1.3	8
		>1	22.2 ± 2.0	7.6 ± 1.2	2.7 ± 0.4	32.5 ± 2.4	27	
	$D > 0.6$	2	>0	6.8 ± 0.9	2.0 ± 0.3	0.4 ± 0.1	9.2 ± 0.9	10
		3	1	4.1 ± 0.6	1.6 ± 0.3	0.3 ± 0.1	6.1 ± 0.6	11
			>1	7.8 ± 0.9	3.8 ± 0.6	0.7 ± 0.1	12.3 ± 1.1	10
>3		1	5.6 ± 0.7	2.9 ± 0.5	0.7 ± 0.2	9.2 ± 0.9	5	
	>1	15.3 ± 1.5	12.0 ± 1.9	3.2 ± 0.5	30.5 ± 2.5	32		
l^+l^+	$0 < D < 0.6$	2	>0	17.9 ± 1.8	4.9 ± 0.8	0.3 ± 0.1	23.1 ± 2.0	26
		3	1	10.2 ± 1.3	3.7 ± 0.6	0.4 ± 0.1	14.4 ± 1.4	11
			>1	10.2 ± 1.2	6.9 ± 1.1	0.8 ± 0.2	17.9 ± 1.6	18
		>3	1	10.7 ± 1.2	4.9 ± 0.8	0.8 ± 0.2	16.4 ± 1.4	16
		>1	22.4 ± 2.0	13.3 ± 2.2	3.0 ± 0.5	38.7 ± 3.0	42	
	$D > 0.6$	2	>0	8.0 ± 1.1	4.3 ± 0.7	0.4 ± 0.1	12.7 ± 1.3	18
		3	1	4.8 ± 0.7	3.2 ± 0.5	0.3 ± 0.1	8.4 ± 0.9	7
			>1	5.4 ± 0.7	7.1 ± 1.2	1.0 ± 0.2	13.5 ± 1.4	10
>3		1	6.3 ± 0.8	5.6 ± 0.9	0.9 ± 0.2	12.8 ± 1.2	12	
	>1	16.5 ± 1.5	22.5 ± 3.7	3.1 ± 0.5	42.1 ± 4.0	46		

SS Dilepton
 $D < 0$

Process	$N_j = 2$	$N_j = 3$	$N_j > 3$
Nonprompt	136.5 ± 13.9	110.3 ± 11.3	57.3 ± 6.1
Total background	192.1 ± 15.6	137.7 ± 11.7	74.0 ± 6.4
$t\bar{t}W$	13.1 ± 0.3	17.6 ± 0.3	13.8 ± 0.3
$t\bar{t}Z$	1.6 ± 0.4	3.1 ± 0.7	4.4 ± 1.0
Total	206.8 ± 15.7	158.4 ± 11.8	92.3 ± 6.5
Observed	229	144	92



$t\bar{t}Z$ Event Yields

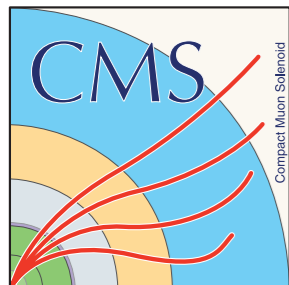


Three-lepton

N_b	N_j	Background	$t\bar{t}W$	$t\bar{t}Z$	Total	Observed
0	2	1032.8 ± 77.1	0.9 ± 0.1	18.2 ± 3.2	1051.9 ± 77.2	1022
	3	293.5 ± 21.4	0.4 ± 0.1	22.3 ± 3.9	316.3 ± 21.8	318
	>3	95.4 ± 7.4	0.3 ± 0.1	26.1 ± 4.6	121.8 ± 8.7	144
1	2	164.6 ± 17.8	1.9 ± 0.3	24.3 ± 4.3	190.7 ± 18.3	209
	3	66.6 ± 6.7	0.9 ± 0.2	41.2 ± 7.2	108.7 ± 9.8	99
	>3	32.8 ± 3.3	0.8 ± 0.1	61.3 ± 10.8	94.9 ± 11.3	72
>1	2	12.9 ± 2.4	1.0 ± 0.2	5.9 ± 1.0	19.8 ± 2.6	32
	3	11.6 ± 1.7	0.6 ± 0.1	17.9 ± 3.2	30.1 ± 3.6	46
	>3	10.6 ± 1.6	0.4 ± 0.1	41.0 ± 7.2	52.0 ± 7.4	54

Four-lepton

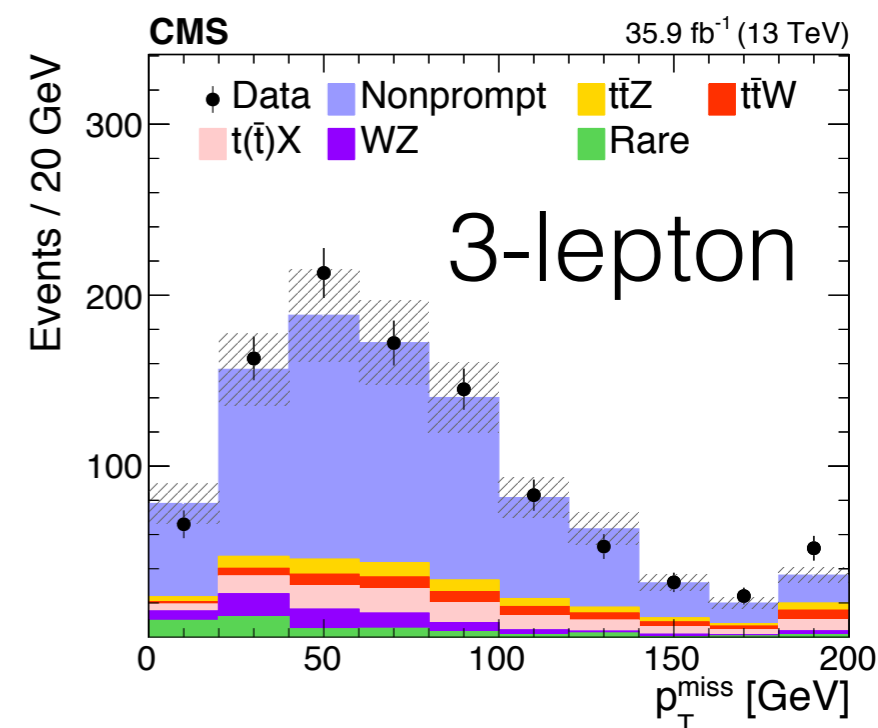
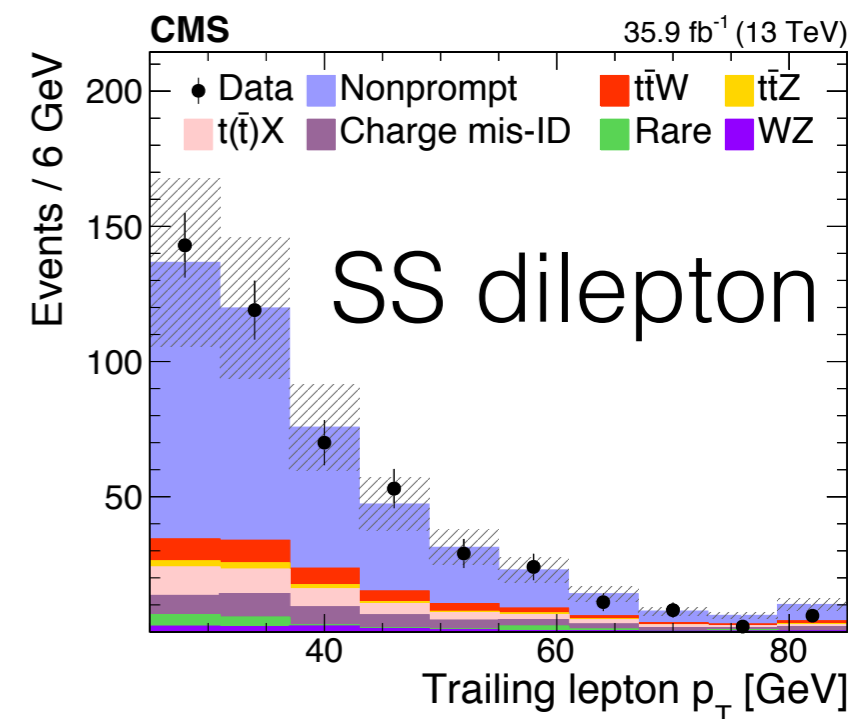
Process	$N_b = 0$	$N_b > 0$
Total background	12.8 ± 2.0	3.3 ± 0.3
$t\bar{t}Z$	4.5 ± 0.6	14.5 ± 1.8
Total	17.2 ± 2.0	17.8 ± 1.8
Observed	23	15

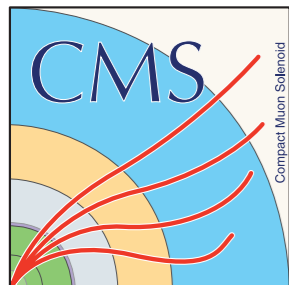


Nonprompt Lepton Background

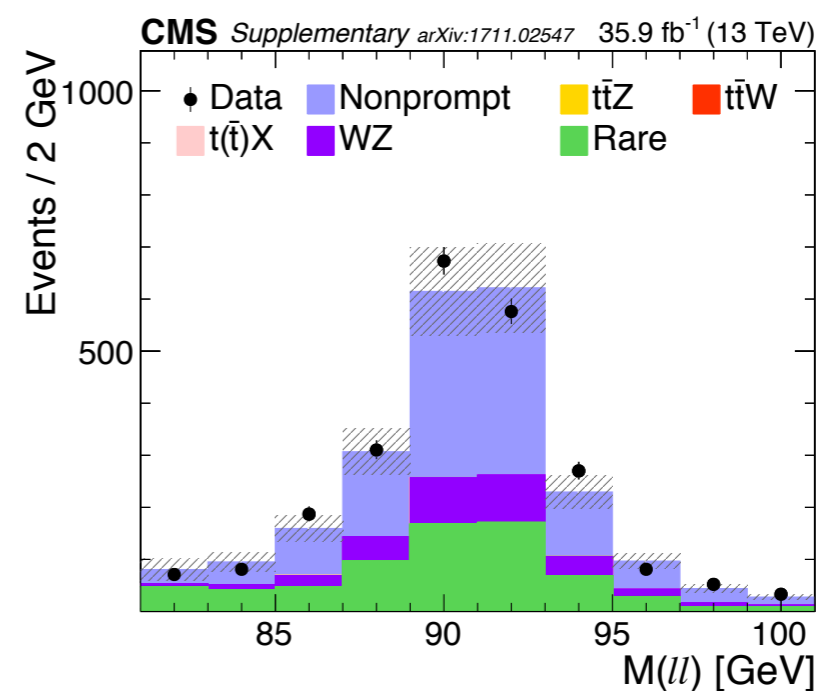
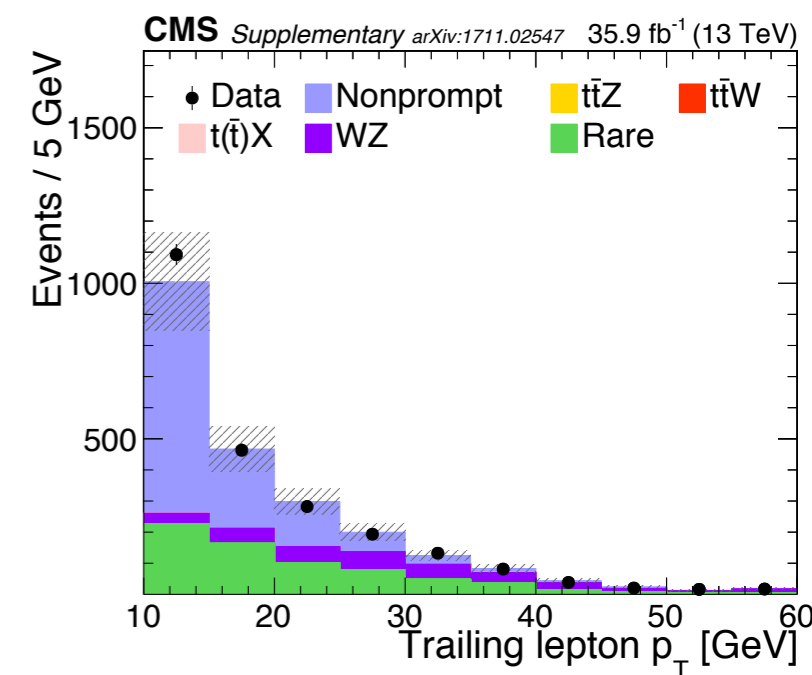
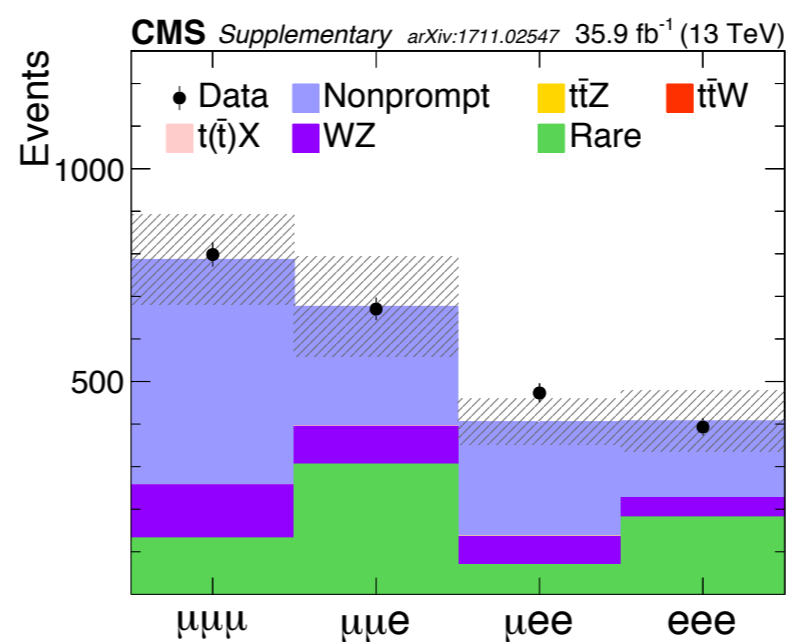
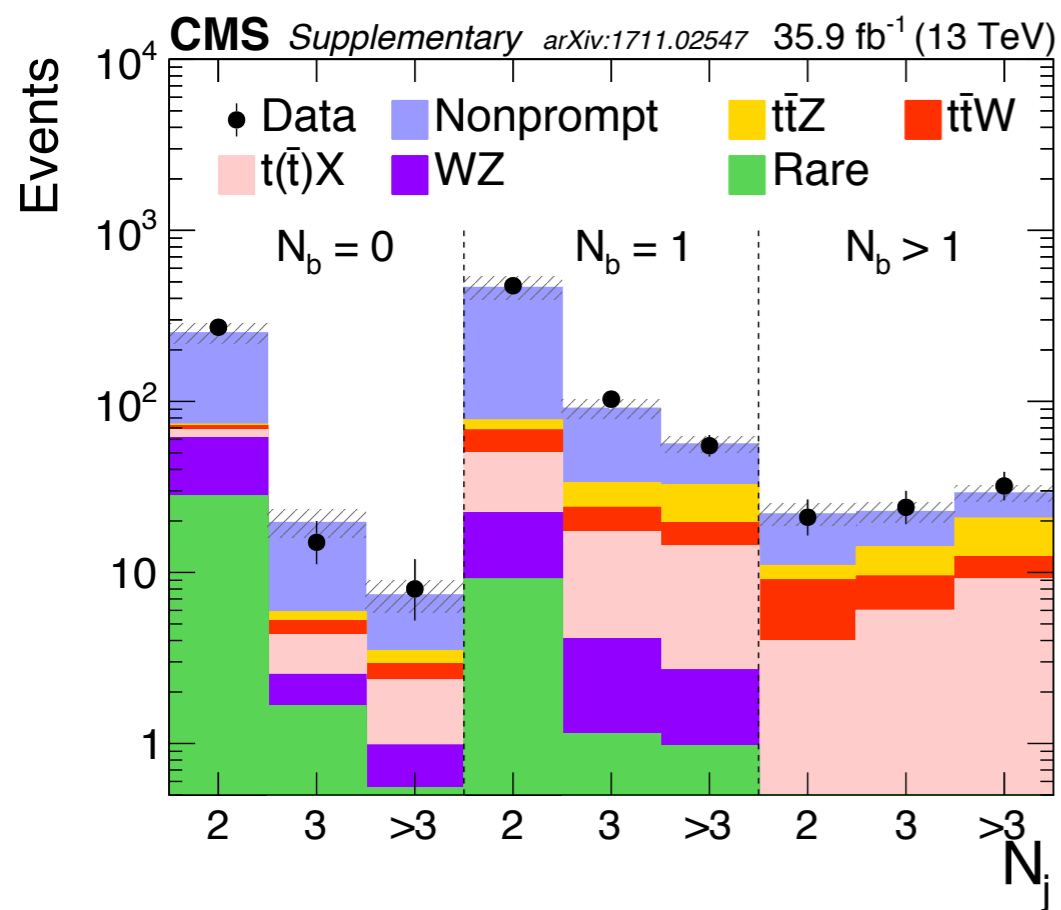


- Measure tight-to-loose lepton ratio (probability lepton passing loose selection passes tight selection)
 - Measured in non prompt lepton enriched control region: 1 loosely isolated lepton and ≥ 1 jet
 - Parameterized as a function of lepton p_T and η
- Define sideband regions, same as signal regions, but where one lepton passes only loose criteria
 - Tight-to-loose ratio used to extrapolate from application region to signal regions
- Verified in MC, and non prompt enriched control regions:
 - BDT < 0 in SS dilepton
 - In 3 lepton, control region defined by either absence of an OSSF lepton pair, or with OSSF having $|m_{\ell\ell} - m_Z| > 10$ GeV and with at least one b jet present.





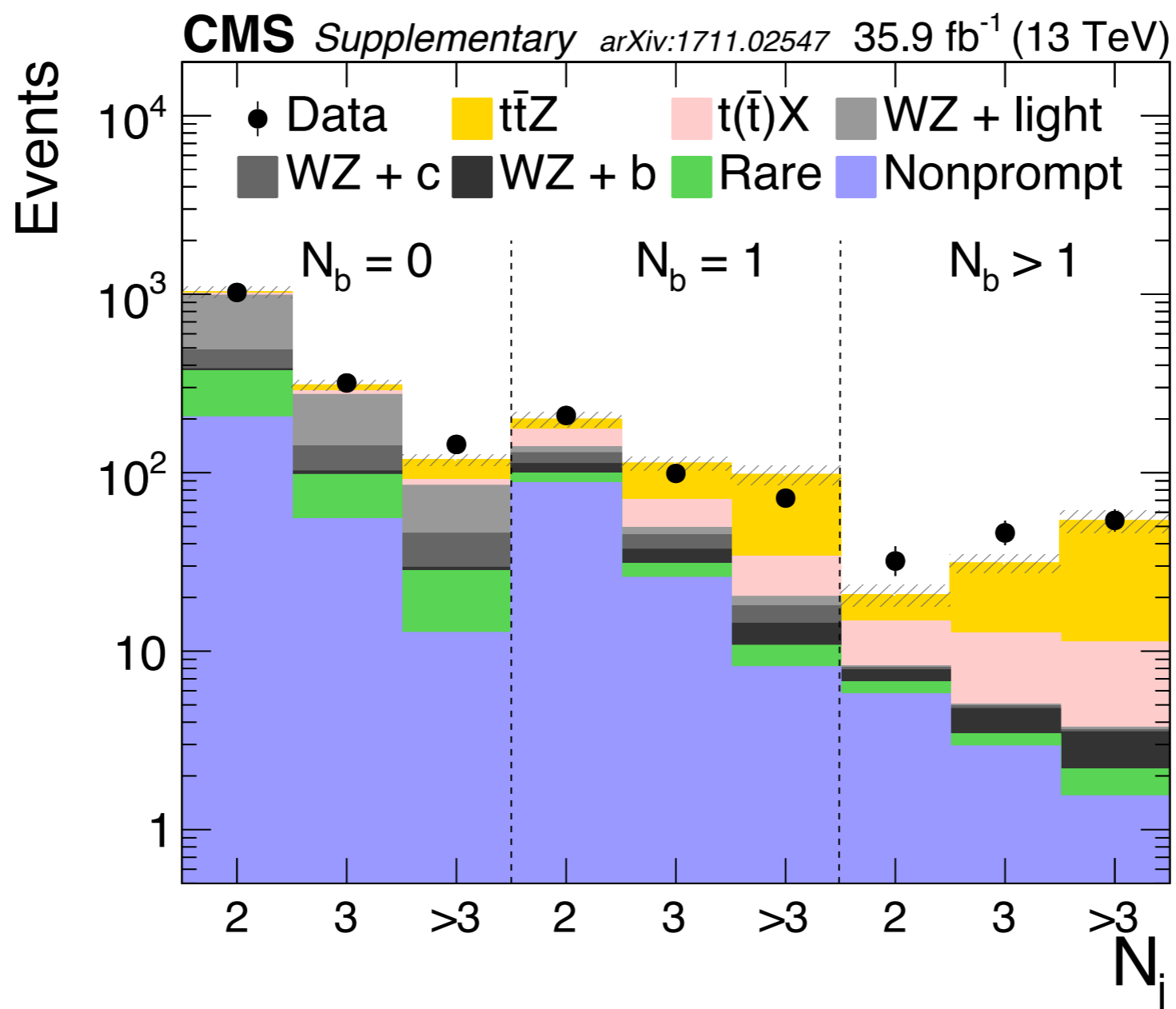
Nonprompt background

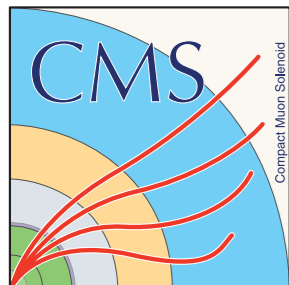


Jet/b-jet categories in non prompt control region for trilepton channel

Trilepton Jet Categories

Trilepton jet categories with WZ background split by heavy flavor content





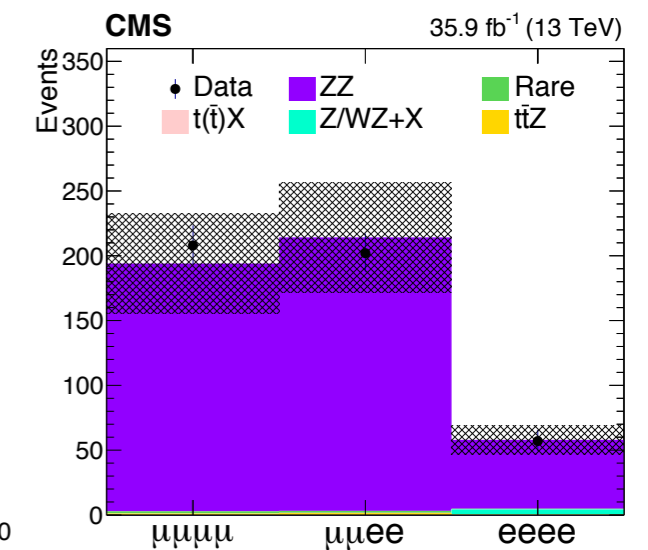
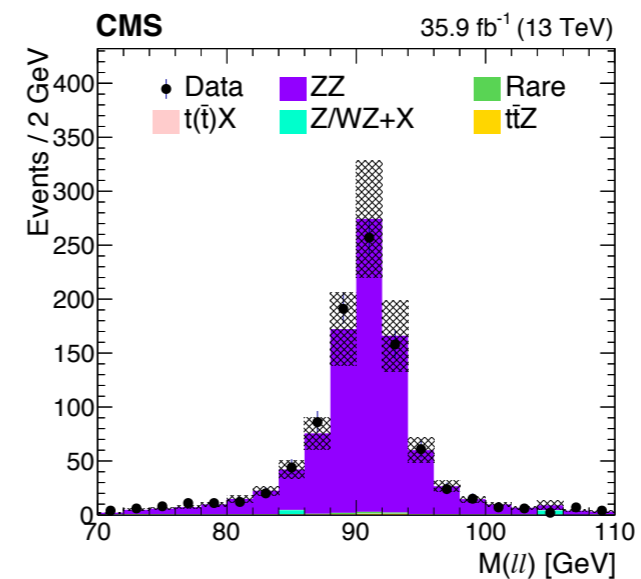
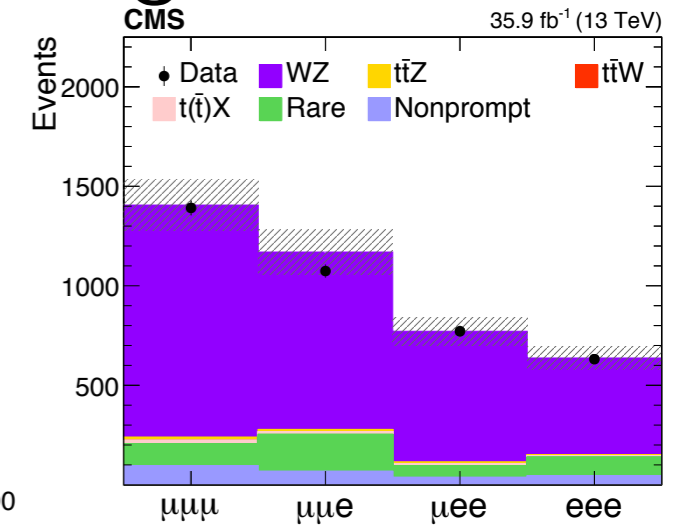
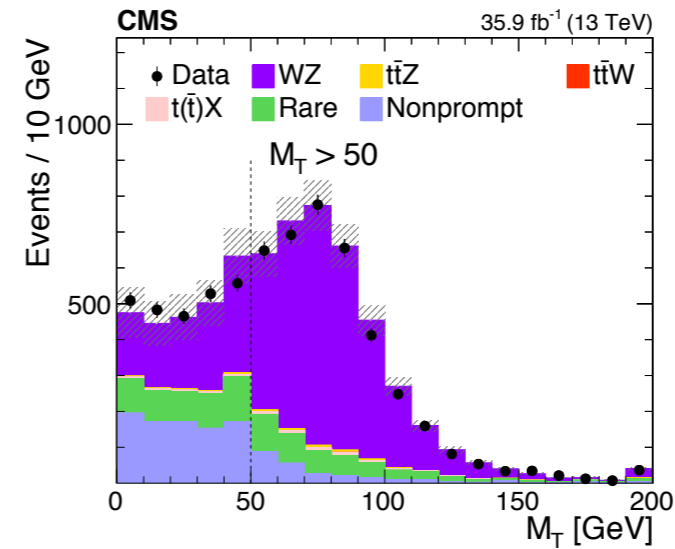
Systematics

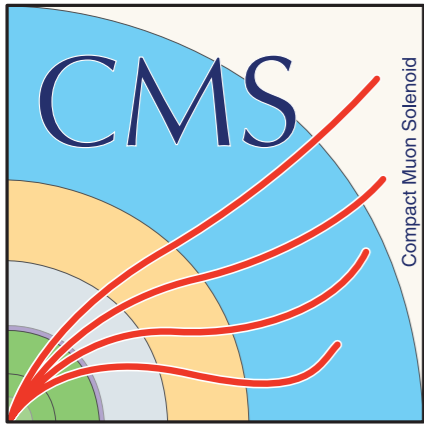


Source	Uncertainty from each source (%)	Impact on the measured $t\bar{t}W$ cross section (%)	Impact on the measured $t\bar{t}Z$ cross section (%)
Integrated luminosity	2.5	4	3
Jet energy scale and resolution	2–5	3	3
Trigger	2–4	4–5	5
B tagging	1–5	2–5	4–5
PU modeling	1	1	1
Lepton ID efficiency	2–7	3	6–7
Choice in μ_R and μ_F	1	<1	1
PDF	1	<1	1
Nonprompt background	30	4	<2
WZ cross section	10–20	<1	2
ZZ cross section	20	—	1
Charge misidentification	20	3	—
Rare SM background	50	2	2
$t(\bar{t})X$ background	10–15	4	3
Stat. unc. in nonprompt background	5–50	4	2
Stat. unc. in rare SM backgrounds	20–100	1	<1
Total systematic uncertainty	—	14	12

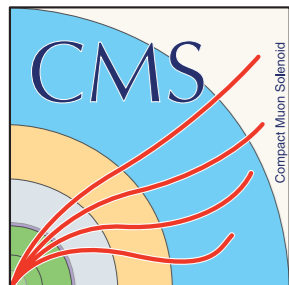
- Charge misidentification of electrons: Estimated by looking at events ee and $e\mu$ events in opposite charge data, reweighted by electron-charge misidentification probability derived from simulation
- WZ/ZZ : Taken from simulation, verified in dedicated control regions

WZ control region:





ttGamma Supporting Material

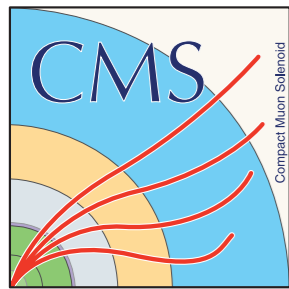


tt+gamma Event Yields



Sample	Genuine photon	Misid. electron	Nonprompt photon	Total
$t\bar{t}+\gamma$	312 ± 17	0.2 ± 0.1	8.5 ± 0.9	321 ± 17
$t\bar{t}$ +jets	—	22 ± 3	215 ± 13	237 ± 14
W+ γ	75 ± 25	—	—	75 ± 25
W+jets	—	—	60 ± 15	60 ± 15
Z+ γ	14 ± 5	1.3 ± 1.1	$0.5^{+0.7}_{-0.5}$	16 ± 5
Z+jets	—	43 ± 28	11 ± 6	54 ± 30
Single t	11 ± 3	2.0 ± 1.3	16 ± 4	29 ± 7
QCD multijet	—	—	31 ± 18	31 ± 18
Total	412 ± 31	69 ± 29	342 ± 28	823 ± 52
Data	—	—	—	935

Sample	Genuine photon	Misid. electron	Nonprompt photon	Total
$t\bar{t}+\gamma$	407 ± 23	0.4 ± 0.3	11 ± 1	418 ± 24
$t\bar{t}$ +jets	—	31 ± 5	291 ± 16	322 ± 17
W+ γ	140 ± 41	—	9.0 ± 6.7	149 ± 45
W+jets	—	—	57 ± 14	57 ± 14
Z+ γ	21 ± 7	—	1.4 ± 0.9	23 ± 7
Z+jets	—	—	9.6 ± 5.8	10 ± 6
Single t	12 ± 3	1.5 ± 1.3	25 ± 13	38 ± 14
QCD multijet	—	—	36 ± 20	36 ± 20
Total	580 ± 48	33 ± 5	440 ± 33	1053 ± 61
Data	—	—	—	1136

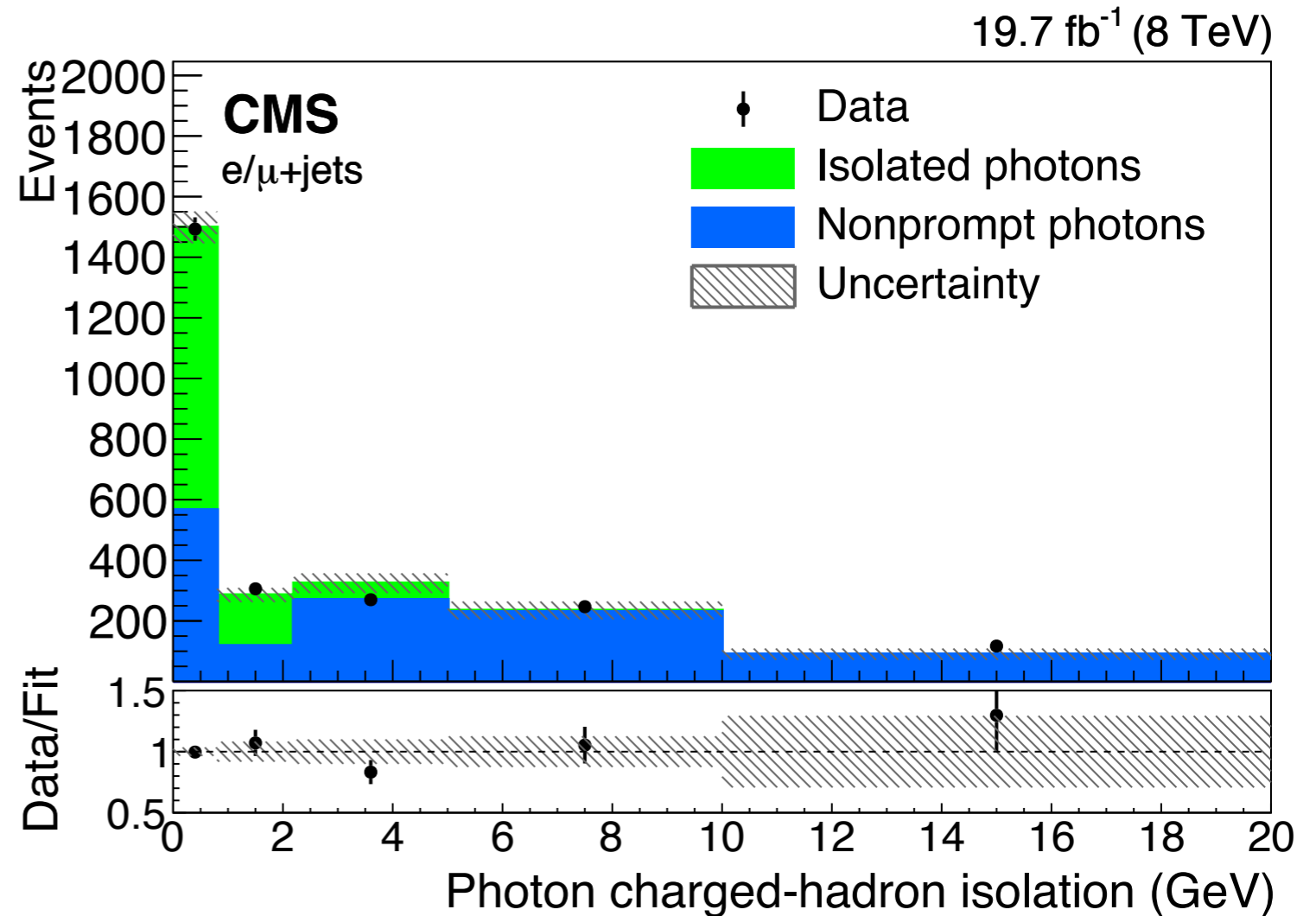
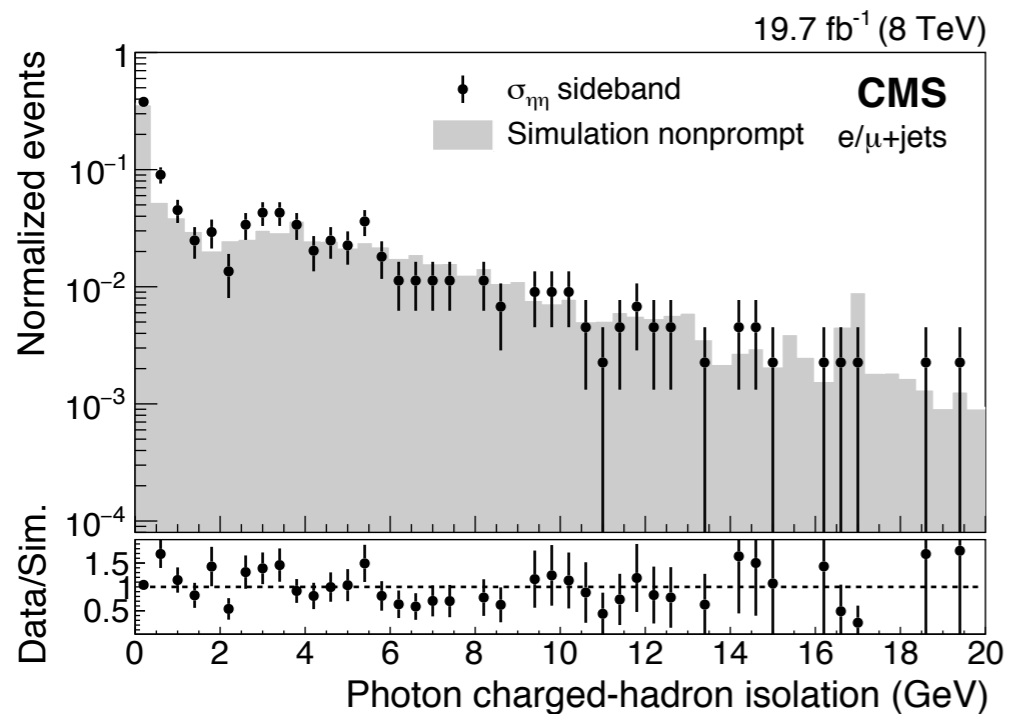
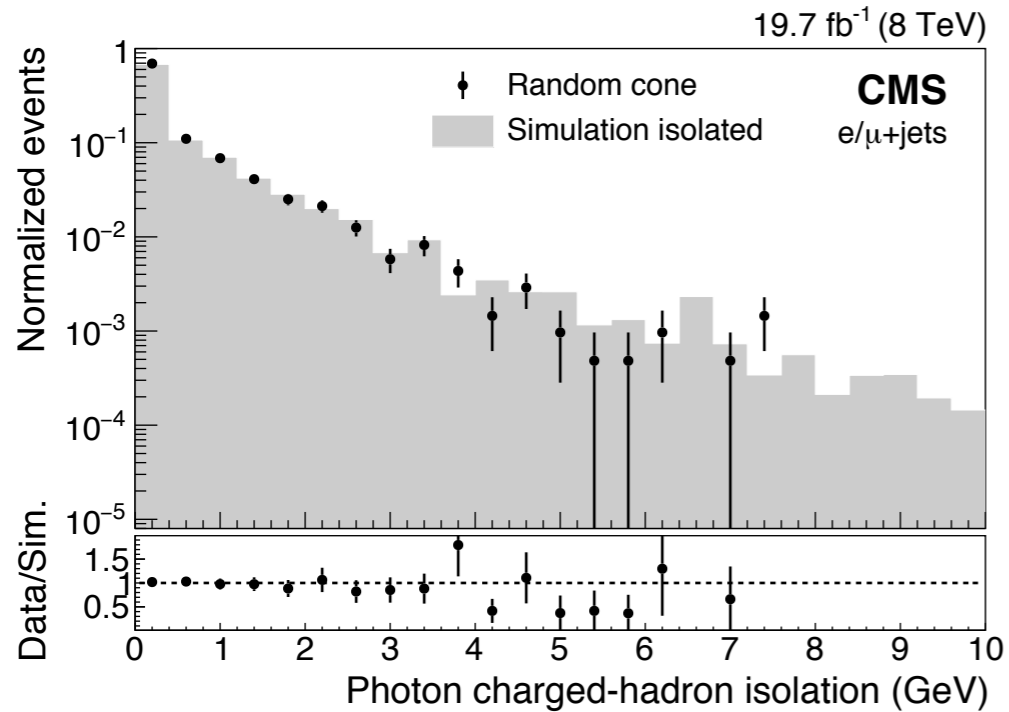


tt+gamma Uncertainties

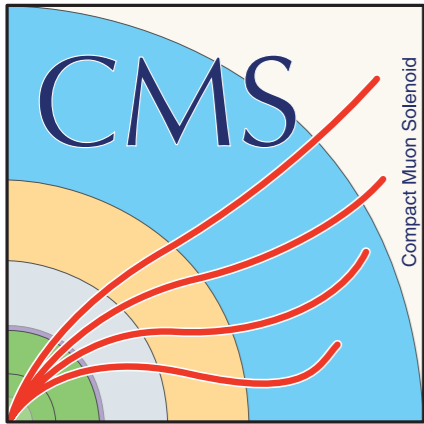


- Largest contribution is statistical (likelihood fit uncertainty)
- Followed by modeling uncertainties:
 - Top mass
 - Q2 scale
 - Jet energy scale corrections

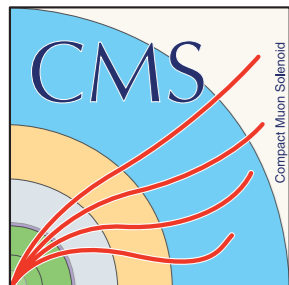
Source	Uncertainty (%)
Statistical likelihood fit	15.5
Top quark mass	7.9
JES	6.9
Fact. and renorm. scale	6.7
ME/PS matching threshold	3.9
Photon energy scale	2.4
JER	2.3
Multijet estimate	2.0
Electron misid. rate	1.3
Z+jets scale factor	0.8
Pileup	0.6
Background normalization	0.6
Top quark p_T reweighting	0.4
b tagging scale factor	0.3
Muon efficiency	0.3
Electron efficiency	0.1
PDFs	0.1
Muon energy scale	0.1
Electron energy scale	0.1
Total	20.7



- Fit to photon charged-hadron isolation to extract photon purity (percent of photons coming from genuine sources)
- Data driven templates of isolated (genuine) photons and non-prompt (fake)



Four top Supporting Material



Systematics



Source	Uncertainty (%)
Integrated luminosity	2.5
Pileup	0–6
Trigger efficiency	2
Lepton selection	4–10
Jet energy scale	1–15
Jet energy resolution	1–5
b tagging	1–15
Size of simulated sample	1–10
Scale and PDF variations	10–15
ISR/FSR (signal)	5–15
$t\bar{t}H$ (normalization)	50
Rare, $X\gamma$, $t\bar{t}VV$ (norm.)	50
$t\bar{t}Z$, $t\bar{t}W$ (normalization)	40
Charge misidentification	20
Nonprompt leptons	30–60

W/Z control regions

- Comparison of data to prediction in ttW and ttZ control regions
- CRW:
 - 2 leptons, 2-5 jets, =2 b-tags
- CRZ:
 - 3 leptons, ≥ 2 jets, ≥ 2 b-tags, OSSF pair with $|m_{\ell\ell} - m_Z| < 15$ GeV

